

European Nuclear Physics Conference 2025

CAEN, 21–26 Sept 2025



ITS3 in ALICE: pioneering bendable wafer- scale sensors for LHC Run 4

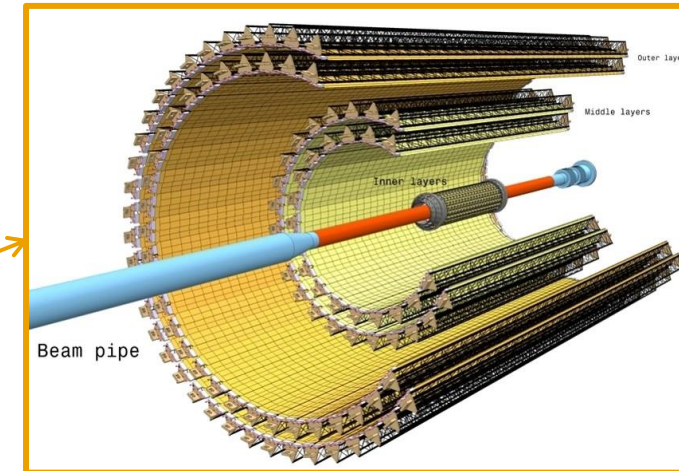
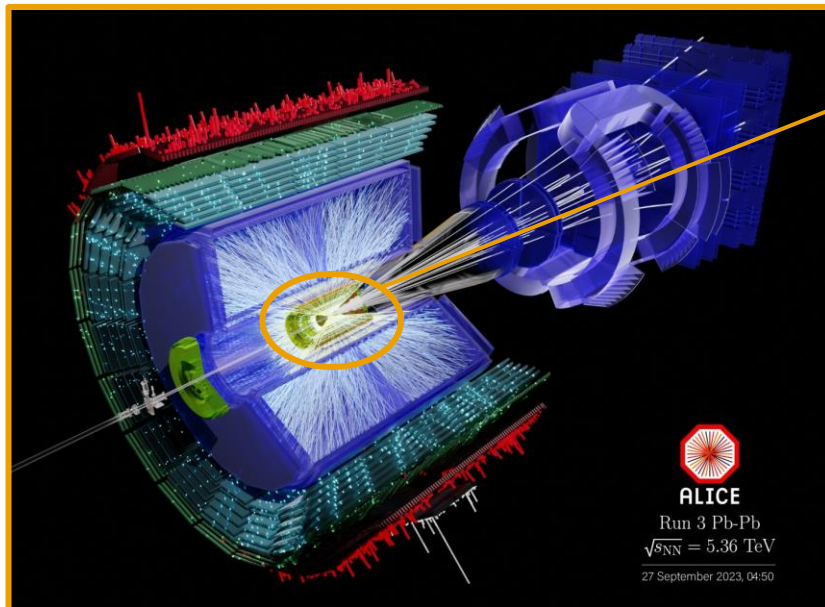
Paola La Rocca

University and INFN Catania

on behalf of the ALICE Collaboration

A Large Ion Collider Experiment

- Optimized for the study of the Quark Gluon Plasma (**QGP**) in heavy ion collisions at the CERN LHC
- Tracking and identification of particles in high multiplicity events
- Interest in low momentum ($\lesssim 1$ GeV/c) particle reconstruction

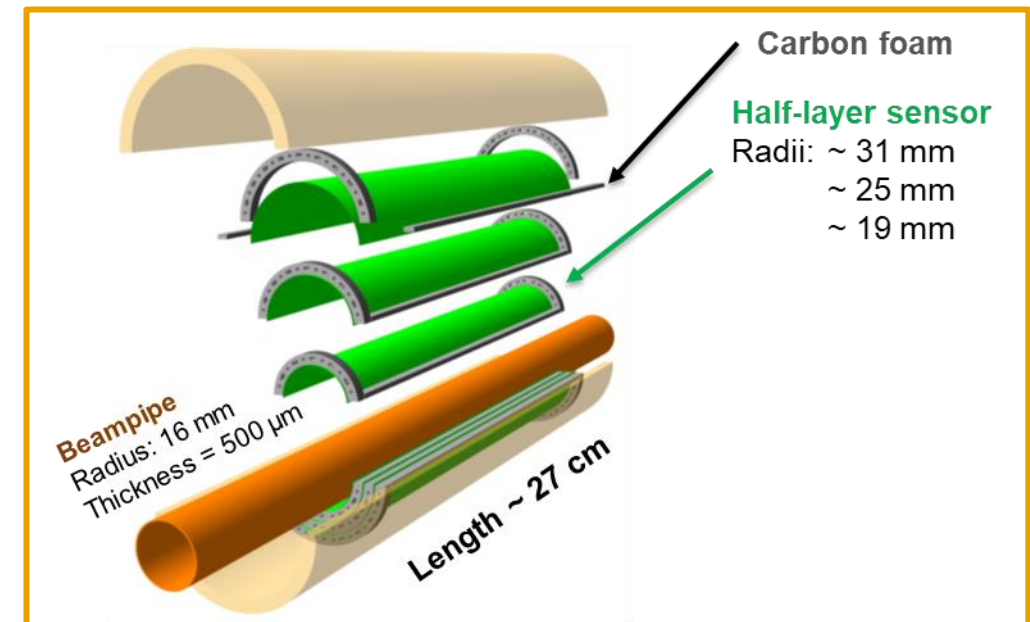


- Inner Tracking System 2 (**ITS2**): current vertex detector taking data since September 2021
- Largest Monolithic Active Pixel Sensor (**MAPS**) detector in high-energy physics
 - 7 layers: Inner Barrel (3 layers) + Outer Barrel (4 layers)
 - 1st layer radius **24 mm**
 - Low material budget: **0.36% X_0** per layer



ITS3: upgrade of the ITS2

- Main physics motivations:
 - improve the precision in heavy-flavour measurements
 - enable detailed studies of (anti)(hyper)nuclei
 - observe rare short-lived states
- Basic idea: **minimize material budget and distance to interaction point**
- ITS3 replaces the Inner Barrel of ITS2 in LS3
- 3 layers of MAPS divided into half-layers:
 - Innermost layer **4mm closer to IP**
 - **Large area** sensors bent around beam pipe
 - **Self supporting**, no rigid mechanical structure
 - **Air cooling**
 - **No circuit boards**
 - Layer thickness reduced to **0.09% X_0**
- **Improvement of a factor 2 in the impact parameter resolution** with respect to ITS2

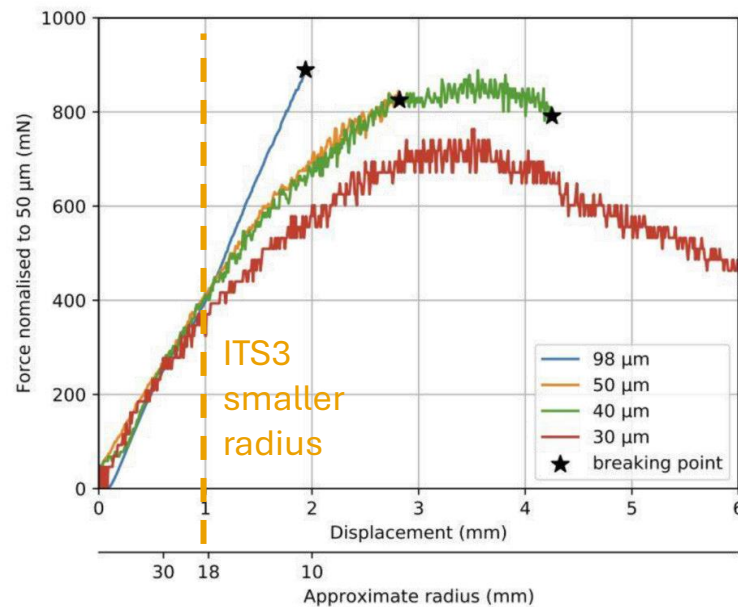


LOI: <https://cds.cern.ch/record/2703140>

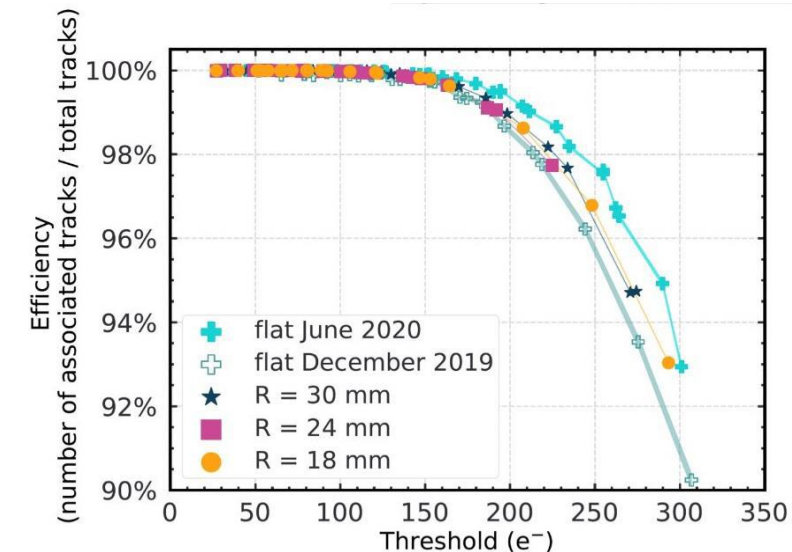
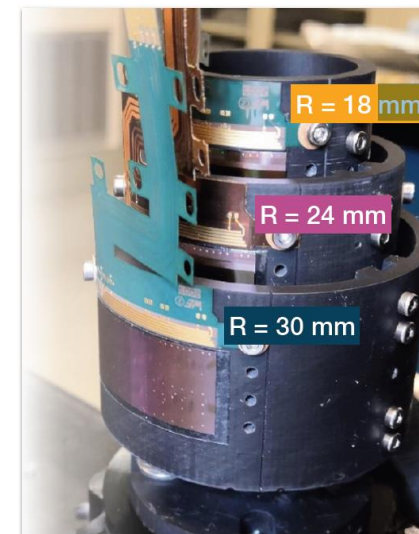
TDR: <https://cds.cern.ch/record/2890181>

Bending of Silicon

- Project target for thicknesses and bending radii are in a “not breaking” regime



- Full mock-up “ μ ITS3”: 6 ITS2 ALPIDE sensors bent to ITS3 target radii
- In-beam results show **no performance degradation - they work as flat chips!**
- Results validated on bent ITS3 small-scale prototypes

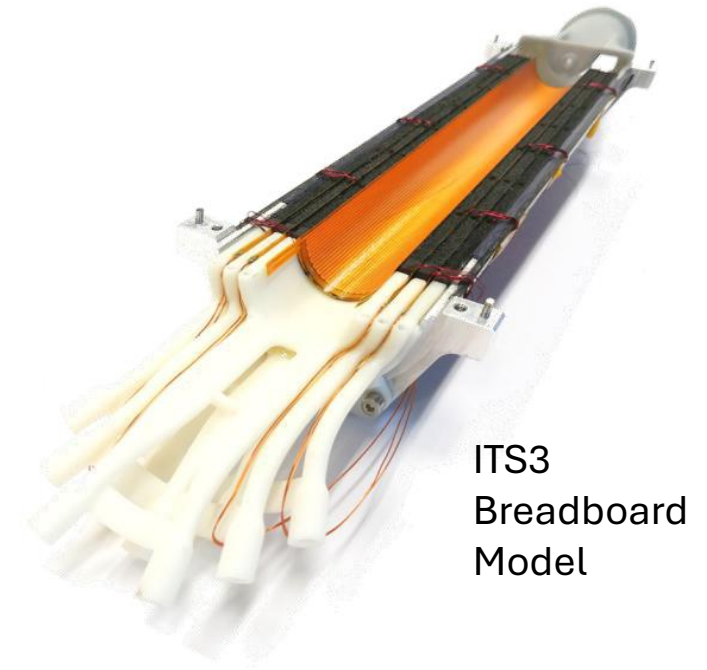
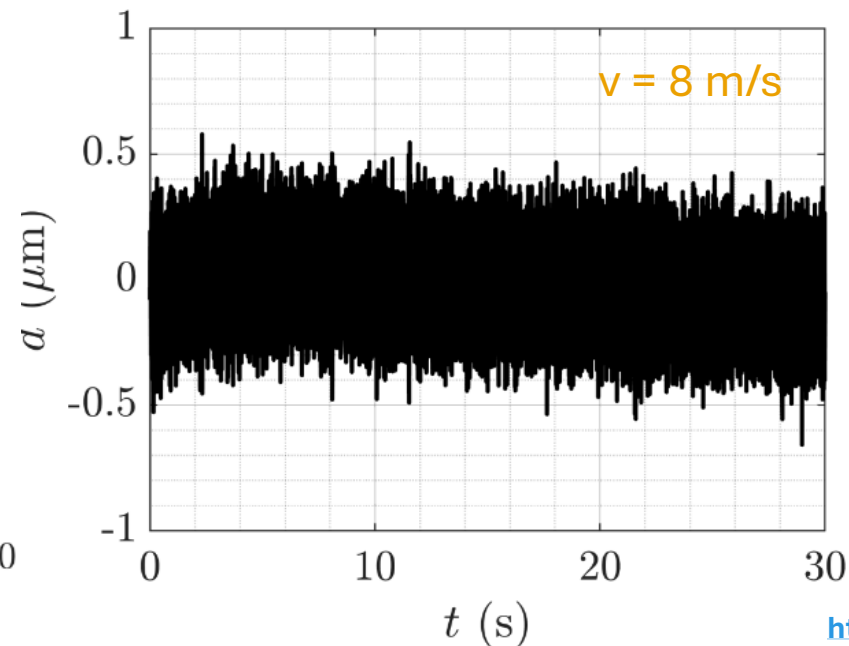
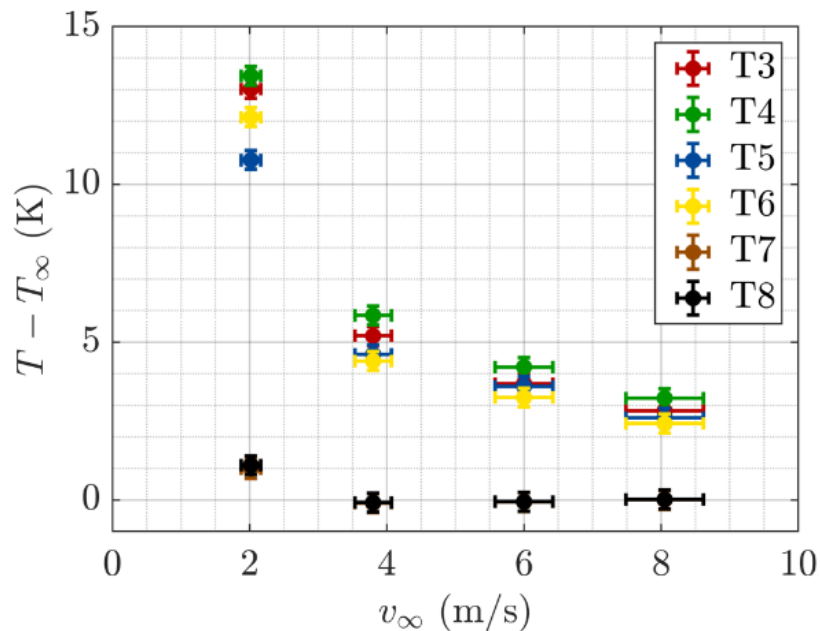


<https://doi.org/10.1016/j.nima.2021.166280>

<https://doi.org/10.48550/arXiv.2502.04941>

Mechanics and cooling solutions

- **Carbon foam** used as support and radiator
- **Air cooling** to keep material budget low
- Tests in wind tunnel using thermal mock-up with heaters & temperature sensors
- Temperature rise well within limits, $\Delta T < 5^\circ \text{C}$
- Vibrations perpendicular to beam axis $\pm 0.4 \mu\text{m}$ (RMS)





Development of the sensor

Project requirements:

- 65 nm CMOS process
- Spatial resolution $\sim 5 \mu\text{m}$
- High efficiency $> 99\%$
- Low Fake Hit Rate (FHR) $< 10^{-6}$ /pixel/event
- Excellent radiation tolerance (up to $4 \times 10^{12} \text{ 1 MeV } n_{\text{eq}} \text{ cm}^{-2}$ and 400 krad)
- Wafer-scale chips
- Low power consumption 40 mW/cm^2 (air cooling)
- $50 \mu\text{m}$ thick (bending)

Development of the sensor

Project requirements:

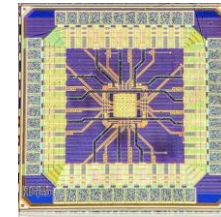
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TECHNOLOGY VALIDATION

MLR1: Multi Layer Reticle 1

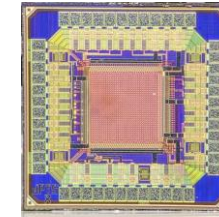
→ first submission in the 65 nm technology

Small area test structures:



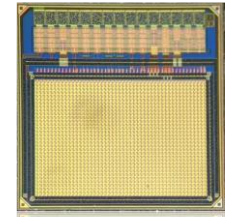
APTS

4x4 px matrix with
direct
analog readout



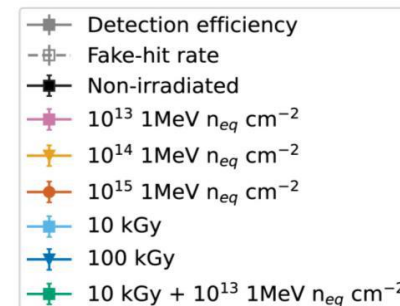
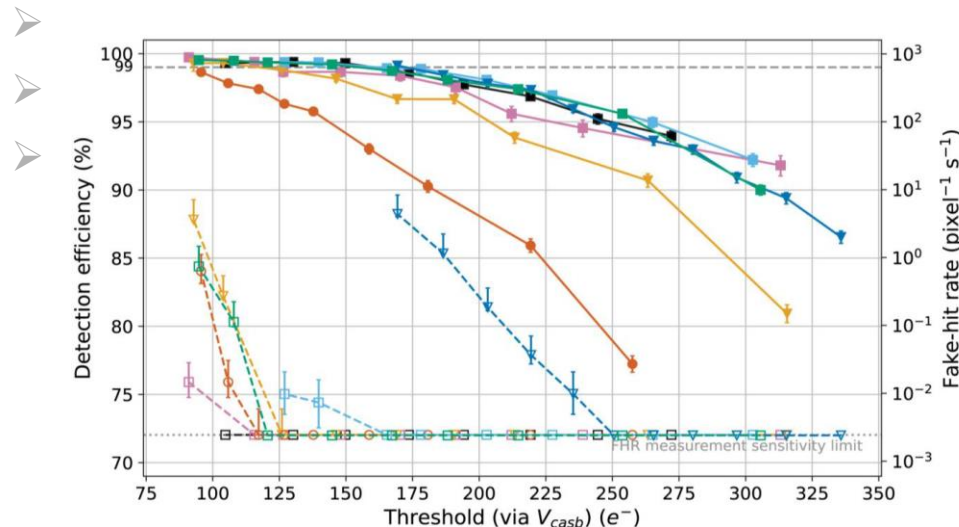
DPTS

32x32 px matrix
with digital
asynchronous
readout



CE65

64x32 px matrix with
rolling shutter
analog
readout



DPTS <https://doi.org/10.1016/j.nima.2023.168589>

DPTS <https://arxiv.org/abs/2505.05867>

APTS <https://doi.org/10.1016/j.nima.2024.169896>

APTS <https://doi.org/10.1016/j.nima.2024.170034>

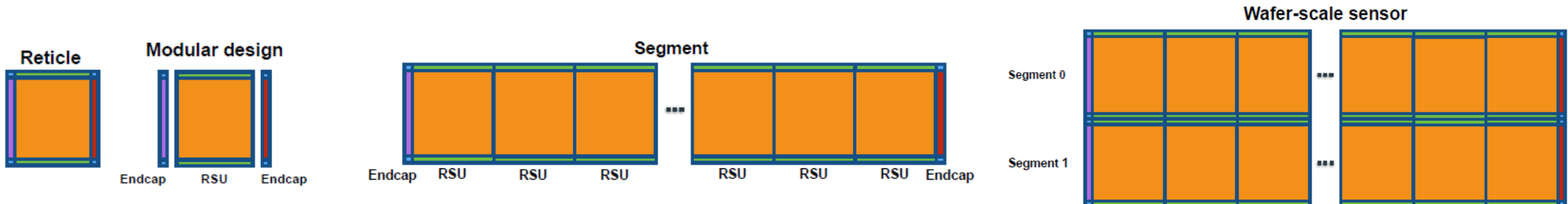
Development of the sensor

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- Low Fake Hit Rate (FHR) $< 10^{-6}$ /pixel/event
- Excellent radiation tolerance (up to 4×10^{12} 1 MeV $n_{\text{eq}} \text{ cm}^{-2}$ and 400 krad)
- **Wafer-scale chips**
 - Low power consumption 40 mW/cm² (air cooling)
 - 50 μm thick (bending)

STITCHING

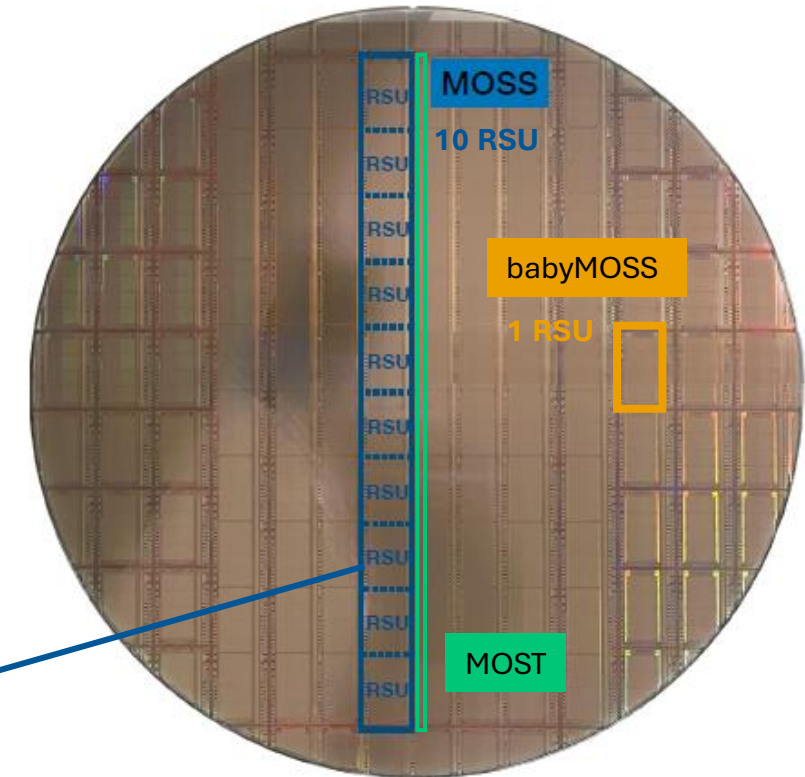
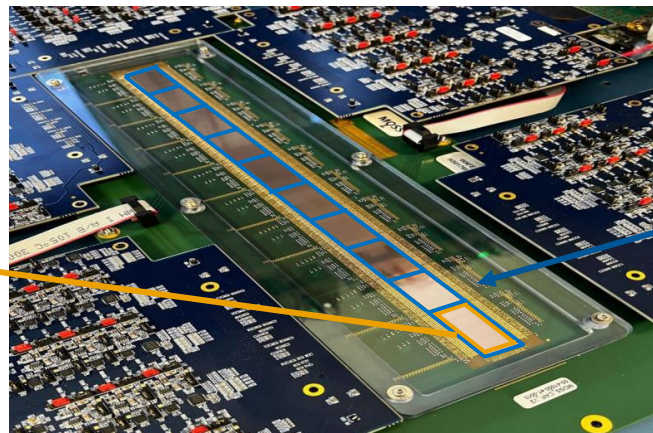
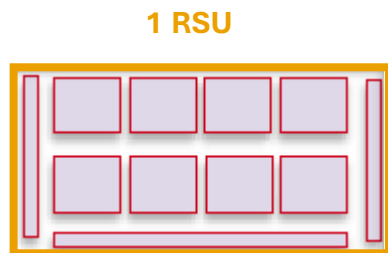
- Size of the chip usually limited to a few cm² by the reticle size in the production process
- Split the design on the reticle:
 - Left End Cap (**LEC**)
 - Repeated Sensor Unit (**RSU**)
 - Right End Cap (**REC**)
- Endcaps and multiple RSUs can be interconnected to a **Segment**
- Multiple independent Segments can be diced out together forming a **wafer-scale sensor**



Wafer-scale stitched MAPS

ENGINEERING RUN 1 (2022)

- First MAPS wafer-scale stitched sensors
- Wafer with various dies (“MOSS”, “MOST”, “babyMOSS”)
- **MOSS: MO**nolithic **S**titched **S**ensor
 - Size (14 x 259 mm²):
 - 6.7 million pixels organised in 10 RSU
 - Each RSU subdivided in 8 individual regions



MOSS results



- Detailed characterisation in:
 - Laboratory
 - Several tests beam at CERN PS and SPS beam lines



MOSS results

- Detailed characterisation in:
 - Laboratory → functional yield higher than **98%**
 - Several tests beam at CERN PS and SPS beam lines

Before picking and bonding on carrier:

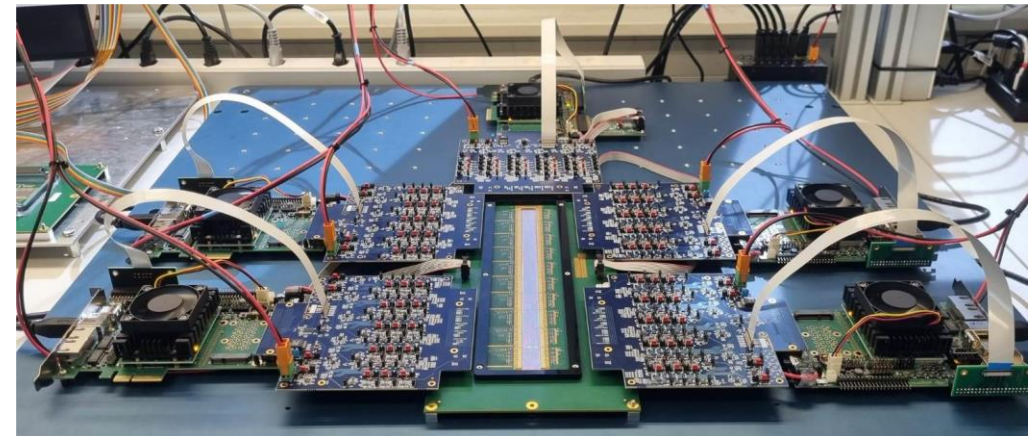
- Wafer-probing

In laboratory, 3 main steps:

- Impedance tests between power nets
- Power ramp
- Functional tests

Tests on all 82 sensors from 14 wafers

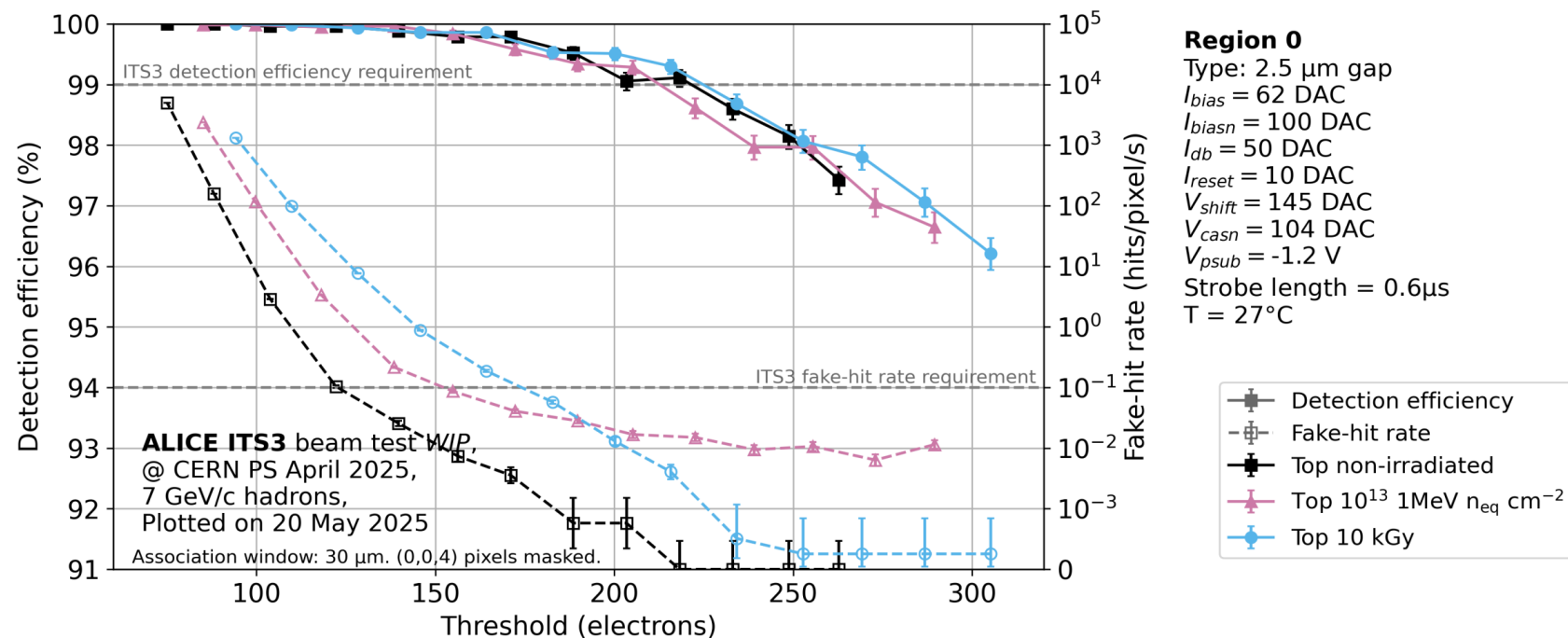
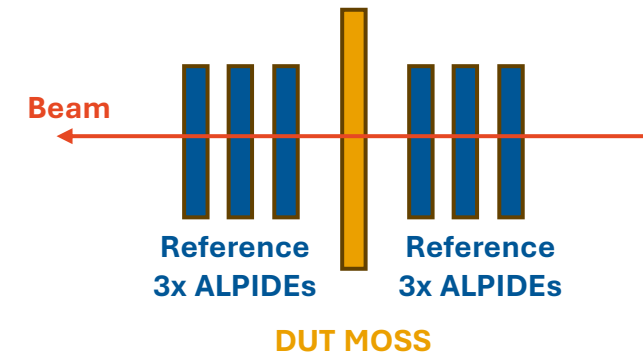
→ **Good performance, uniform behavior, high yield**



MOSS results

➤ Detailed characterisation in:

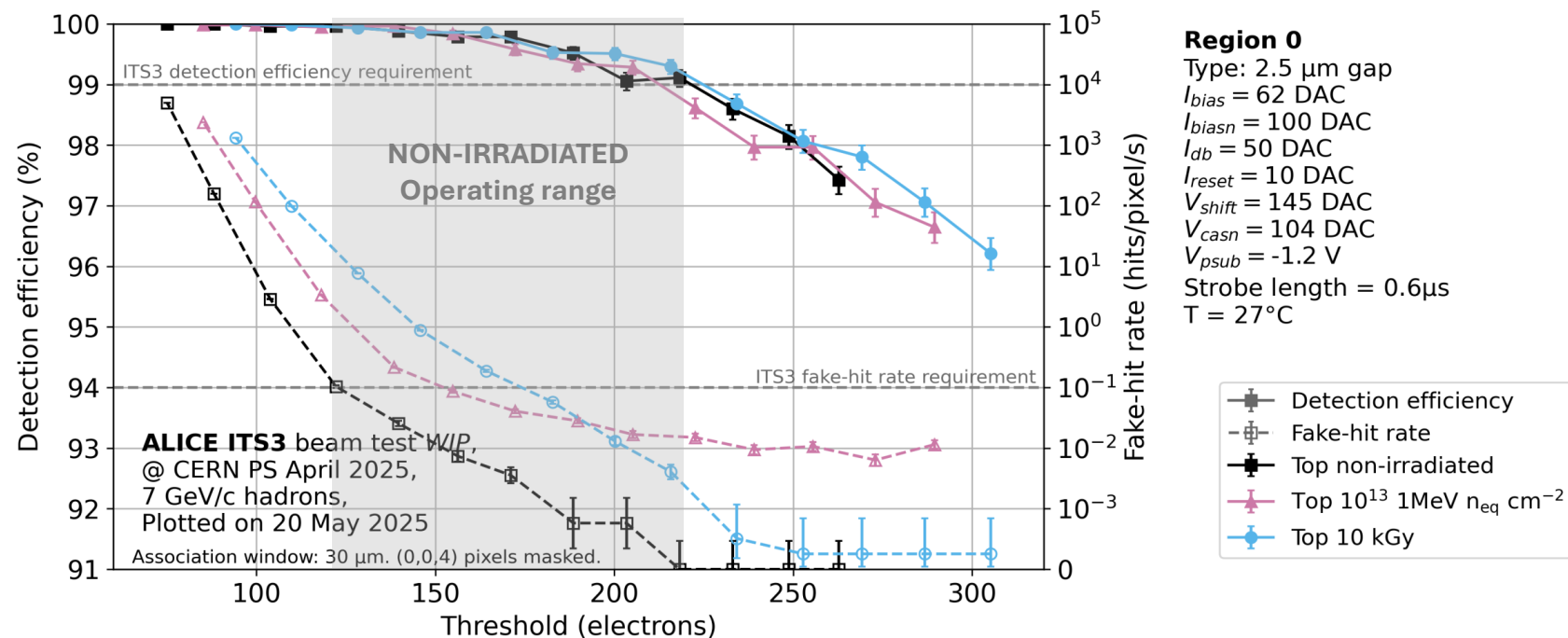
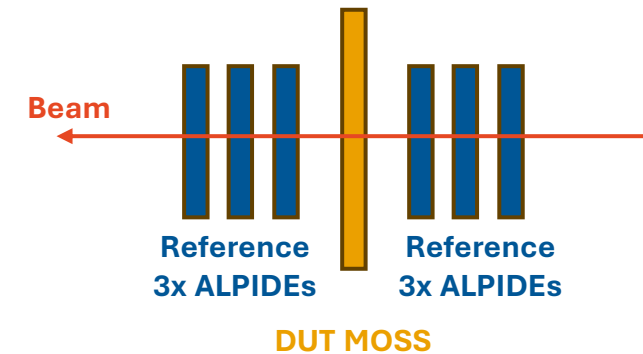
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MOSS results

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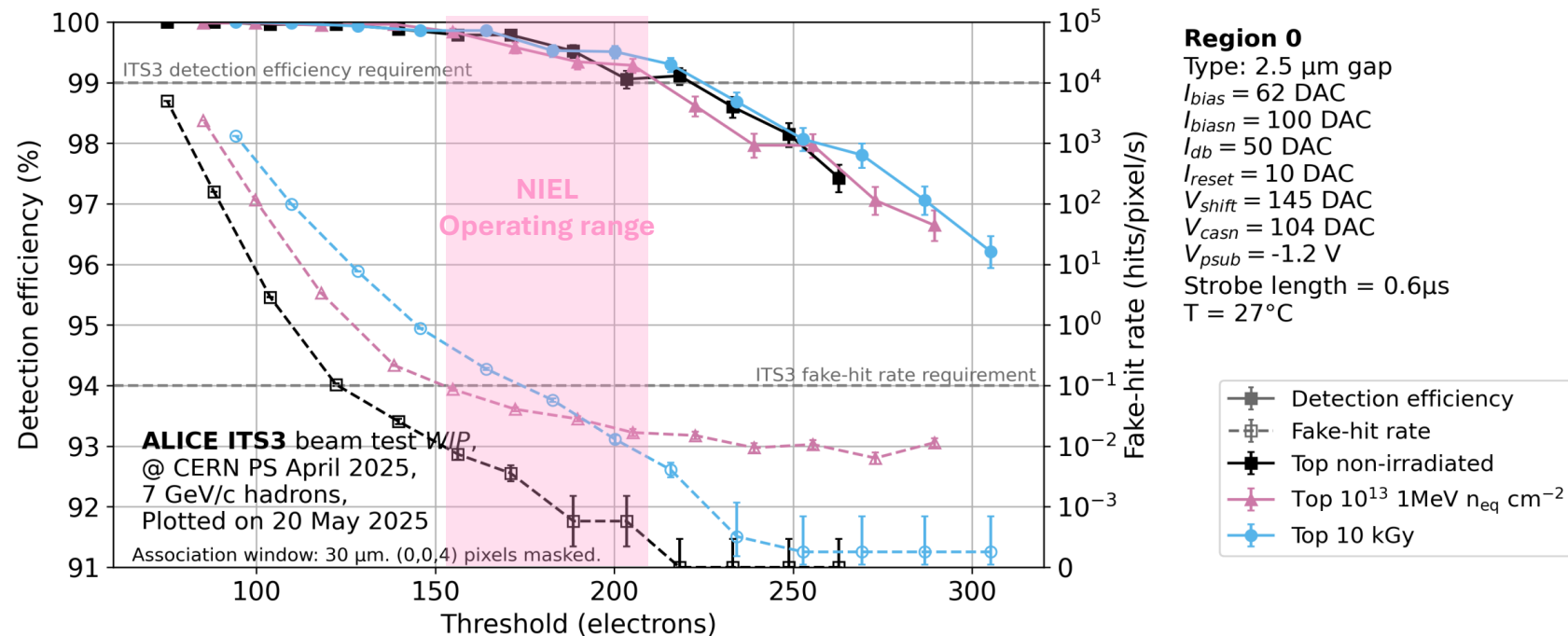
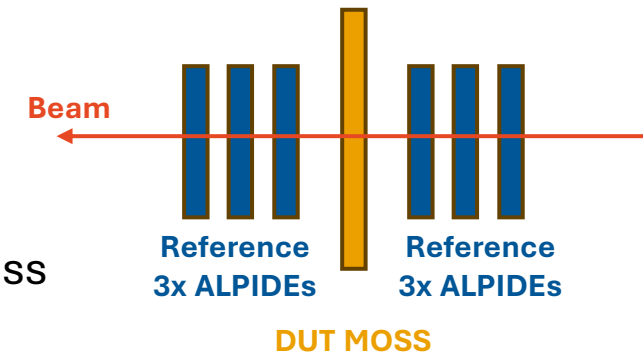
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MOSS results

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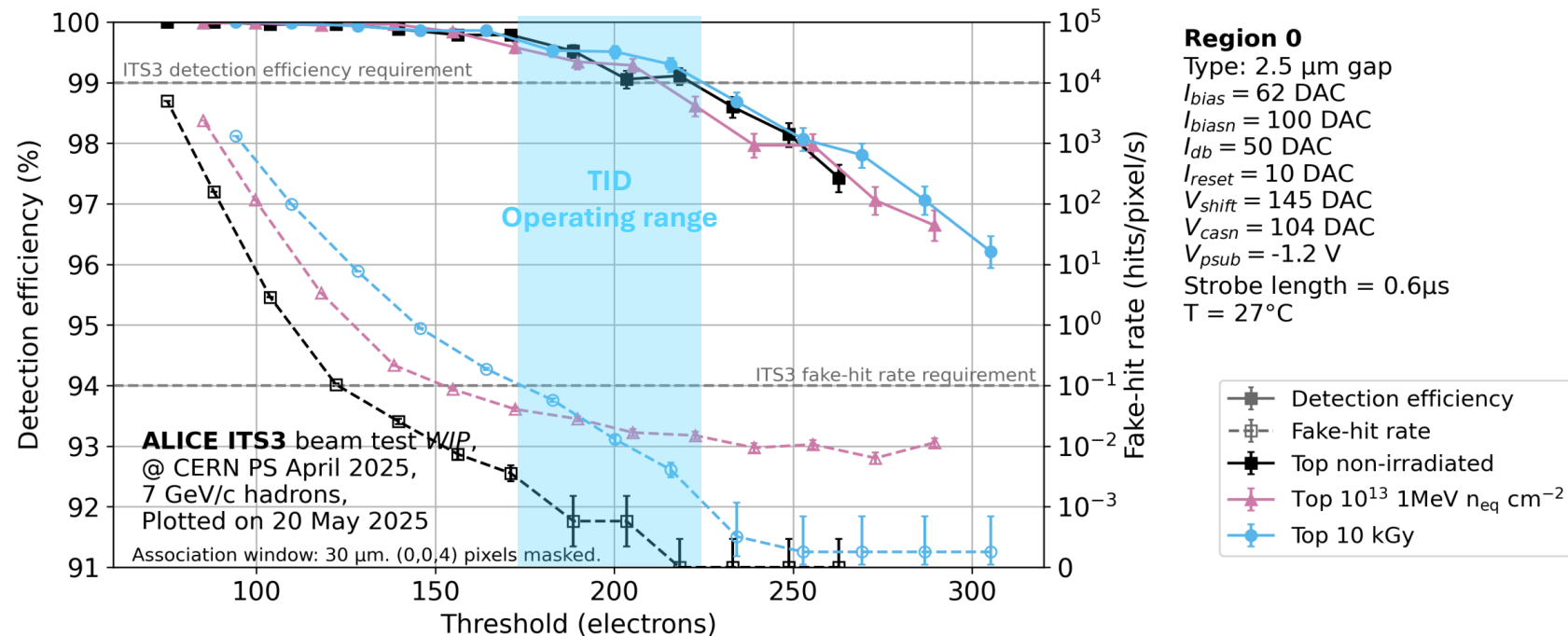
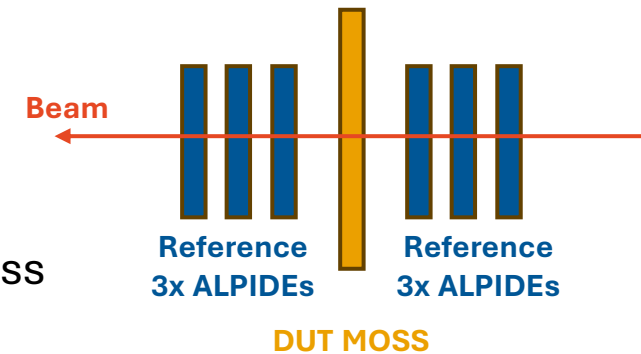
- Laboratory → functional yield higher than 98%
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- **Non-Ionizing Energy Loss (NIEL)** affects mainly the charge collection process



MOSS results

➤ Detailed characterisation in:

- Laboratory → functional yield higher than 98%
- Several tests beam at CERN PS and SPS beam lines
- **Non-Ionizing Energy Loss (NIEL)** affects mainly the charge collection process
- **Total Ionizing Dose (TID)** radiation affects the in-pixel front-end

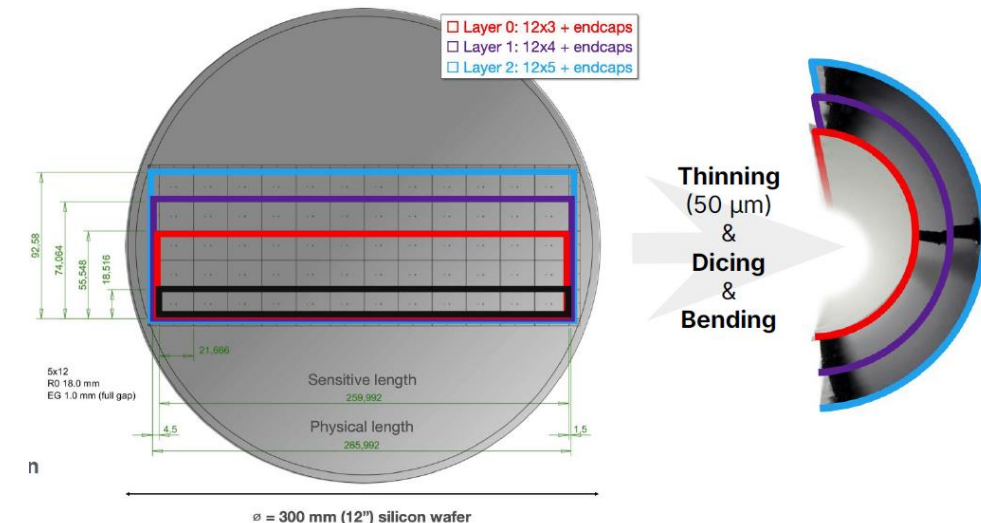
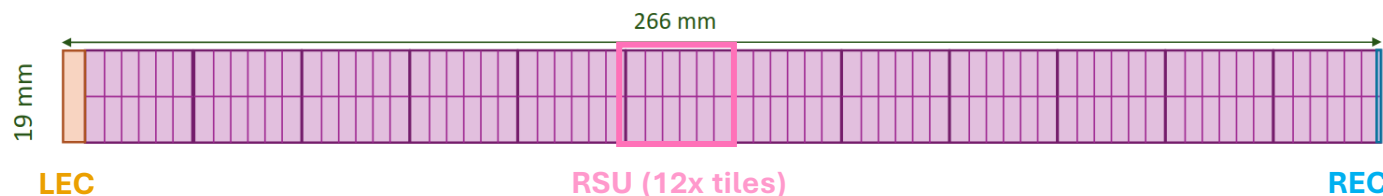


MOSAIX -full functionality prototype ITS3 sensor



ENGINEERING RUN 2 (submitted in July 2025)

- **MO**nolithic **S**titched **A**ctive **pIX**el: incorporate learnings from MLR1, MOSS and MOST testing
- **Modular design**: each sensor is divided into 3, 4, or 5 segments with 12 RSUs
- Pixel pitch: **20.8 x 22.8 μm^2** (9.97 M pixels in 1 segment)
- **Stitched metal lines** carry both power and data
- Sensitive area fraction: **93%**
- Several variants of analog front-end for optimization studies





Outlook...

- **CHARACTERIZATION OF ER2 MOSAIX CHIPS** – starting from Dec 2025
- **QUALIFICATION MODELS (QMs)**
 - Fully integrated, final-grade assemblies including MOSAIX sensors (+ mechanics, cooling, slow control, powering, readout...)
 - Goals: test half-detector performance and serve as reference system for Run 4
- **ENGINEERING RUN 3** – final sensor production (2026)
- **ITS3 INSTALLATION** in 2028 for Run 4

...and conclusions

ITS3 activities progressing on schedule:

- Bent MAPS: operability proven
- 65 nm CMOS process: validated
- Large-area sensors: qualification being finalized
- Mechanical & thermal: validated

ITS3 technology will seed the new ALICE3 tracker, proposed for LHC Run 5
(see D. Colella talk “ALICE upgrades for LHC Run 4 and beyond ”)

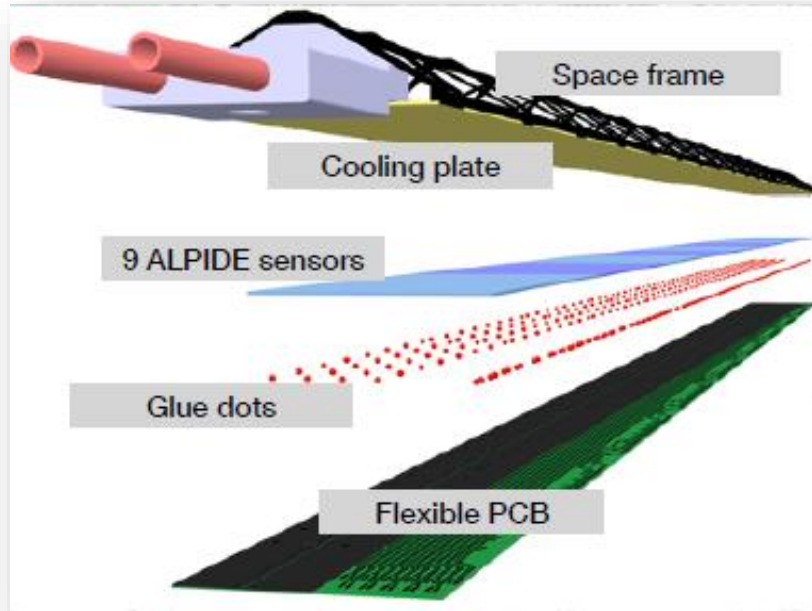


Thank you!

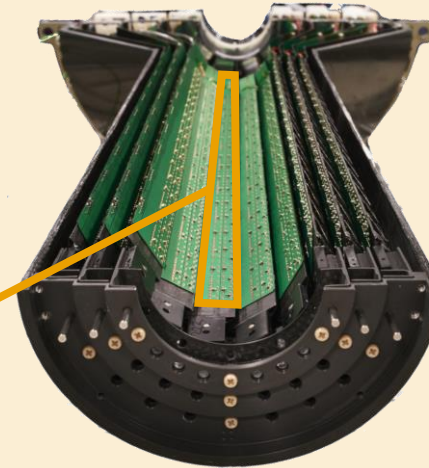
Backup slides



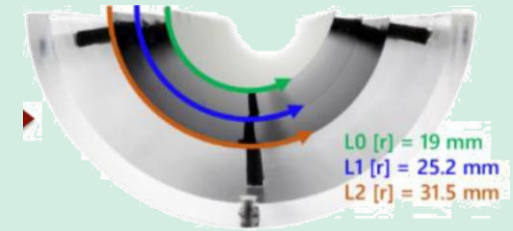
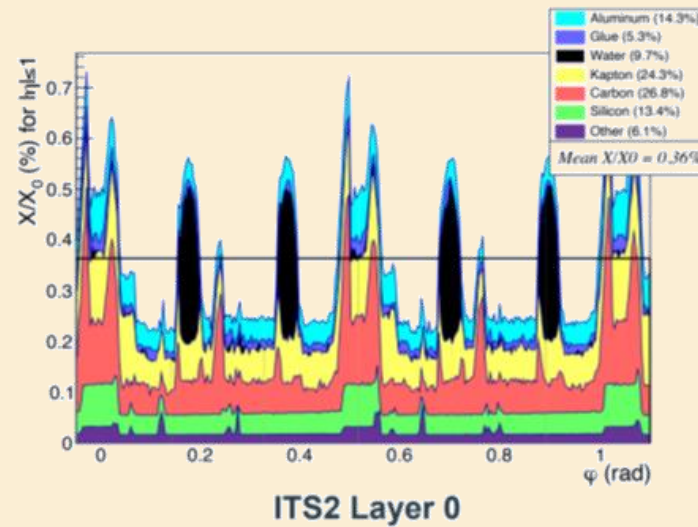
From ITS2 to ITS3



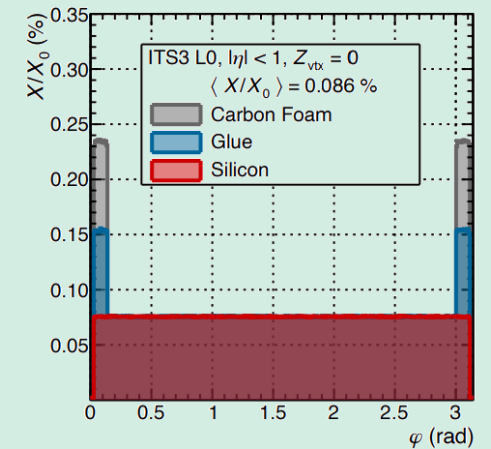
Innermost half-layer: 54 sensors replaced by 1!



ITS2 Inner half-barrel



ITS3





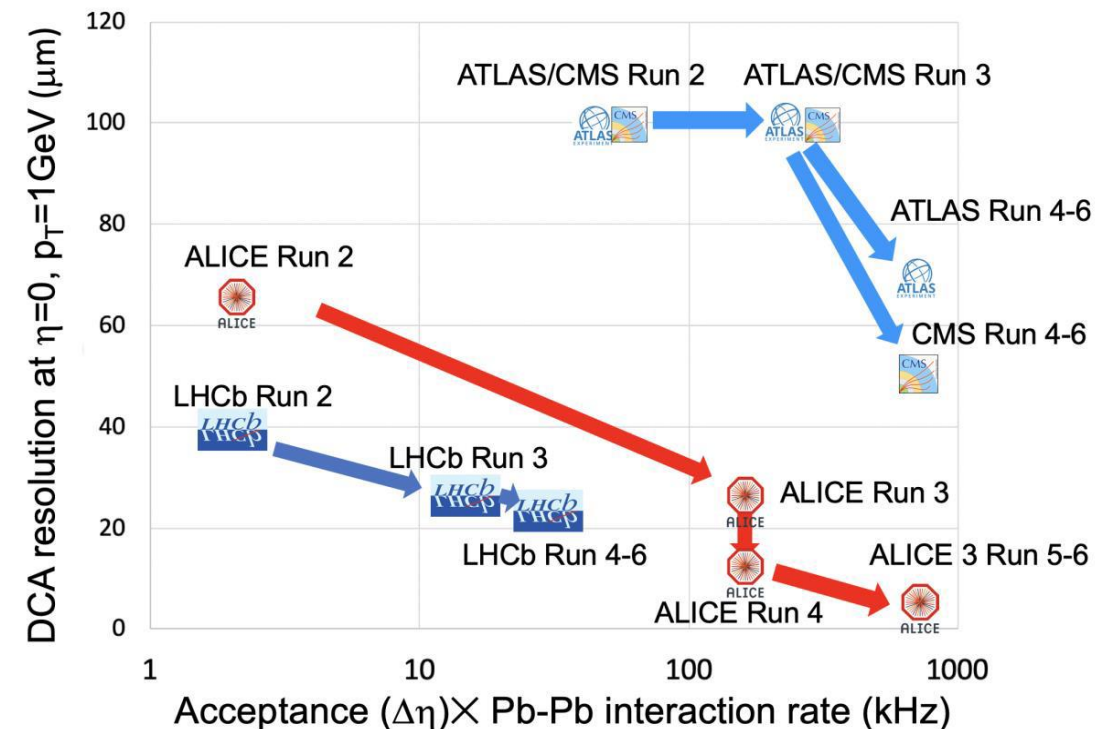
ITS3 Physics Motivations

ALICE 2 → ALICE 2.1

- Impact parameter resolution reduced by a factor of ~ 2 in low p_T region
- Tracking efficiency up to more than 30% higher, in low p_T region

Most striking improvements in the study of:

- Low momentum charm and beauty hadrons
- Low-mass dielectrons
- Beauty baryons
- Beauty-strange mesons
- Charm strange and multi-strange baryons
- Light charm hypernuclei



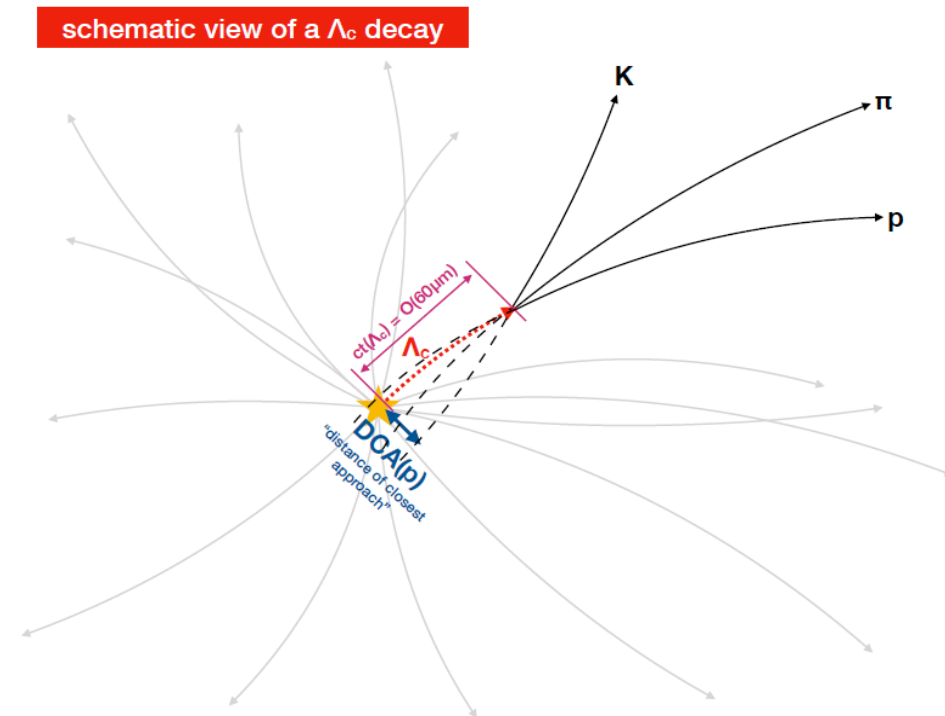
Measurement of Lambda-c (Λ_c)

In heavy-ion collisions the production of charm and beauty baryons is expected to be significantly enhanced:

- recombination with light-flavour quarks present inside QGP
- hadron-mass-dependent radial collective flow

However current results have limited statistical precision!

The measurement requires very precise tracking and impact parameter resolution

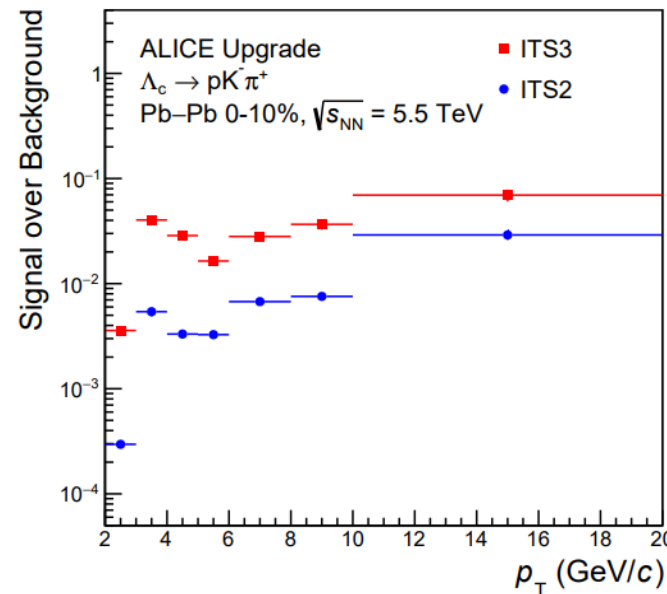
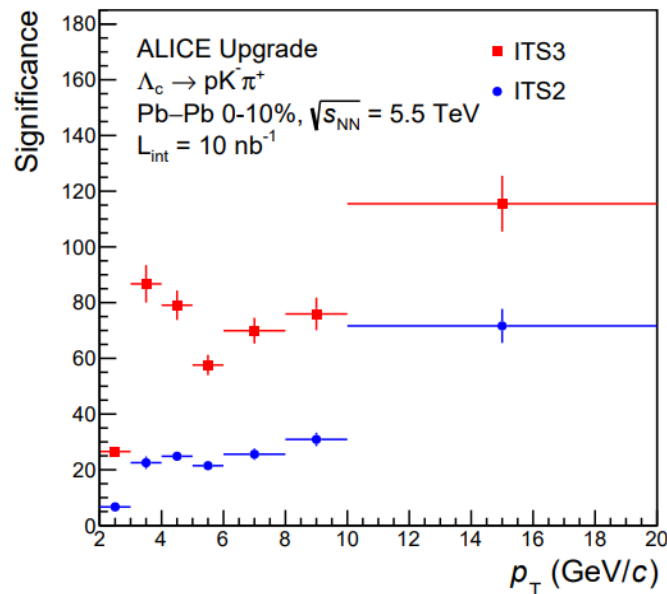




Measurement of Lambda-c (Λ_c)

Large improvement (wrt ITS2) of significance (factor 4) and S/B ratio (10), thanks to:

- better pointing resolutions \rightarrow larger rejection of the combinatorial background
- larger efficiency for the signal selection



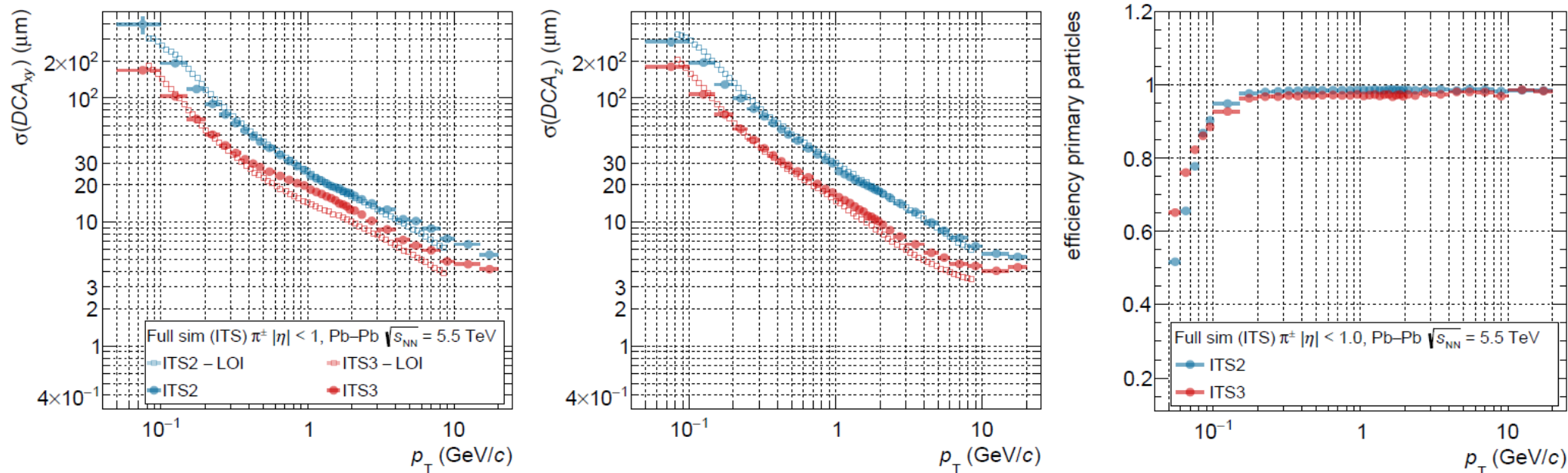
Precise measurement of Λ_c/D ratio at low p_T

- Λ_c production \rightarrow total cc cross section

BENCHMARK FOR ITS3

ITS3 Performance from simulations

Large improvement for low transverse momenta

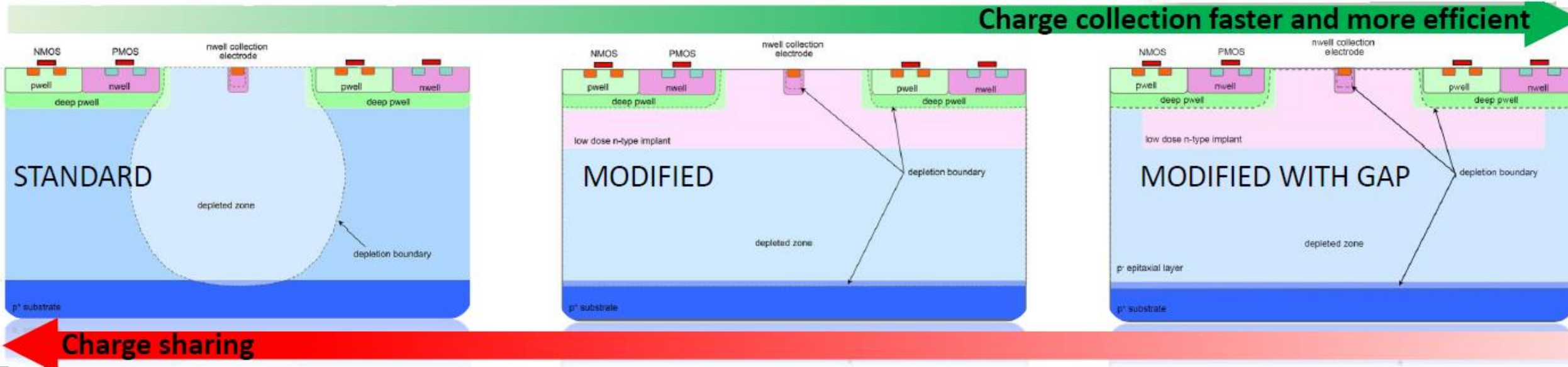
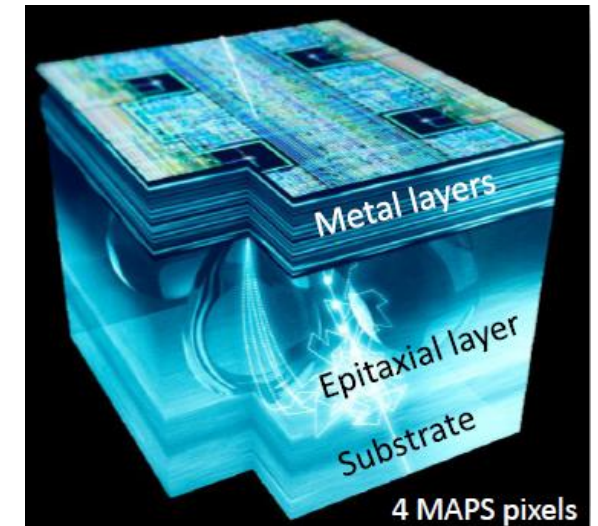


The 65 nm CMOS technology

- Tower Partners Semiconductor Co. (TPSCo) 65 nm CMOS imaging process for Monolithic Active Pixel Sensors (MAPS)
- Chosen for ALICE ITS3 detector and under study by the CERN EP R&D on monolithic pixel sensors

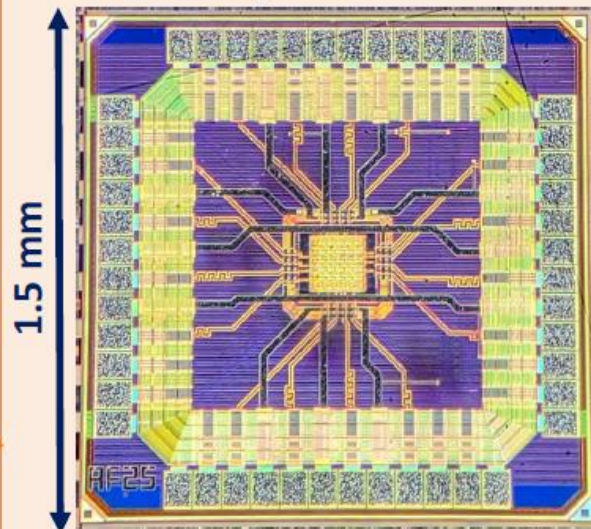
Key advantages:

- High radiation hardness
- 5 μm 2D spatial resolution
- Low power consumption
- Large wafers (\varnothing 300 mm)



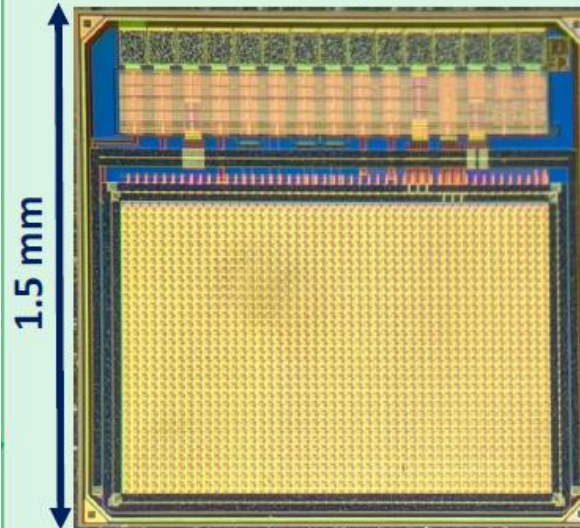
MLR1 sensor prototypes

APTS: Analog Pixel Test Structure



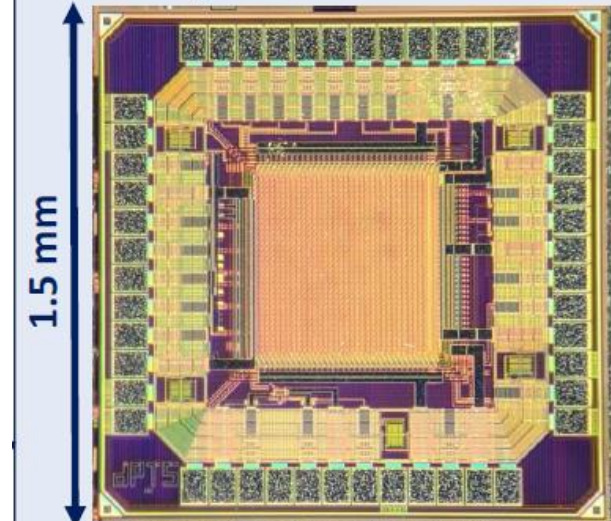
- 6×6 pixel matrix
- Pitch: 10, 15, 20, 25 μm
- Analogue readout of central 4×4 submatrix
- Output buffer in two versions: Source Follower (SF) and Op Amp (OA)
- **Goal:** explore pixel designs

CE65: Circuit Exploratoire 65



- 64×32 pixel matrix, 15 μm pitch (3 subvariants: AC, DC and SF)
- 48×32 pixel matrix, 25 μm pitch
- Rolling shutter readout (50 μs integration time)
- **Goal:** explore pixel matrix uniformity and rolling shutter

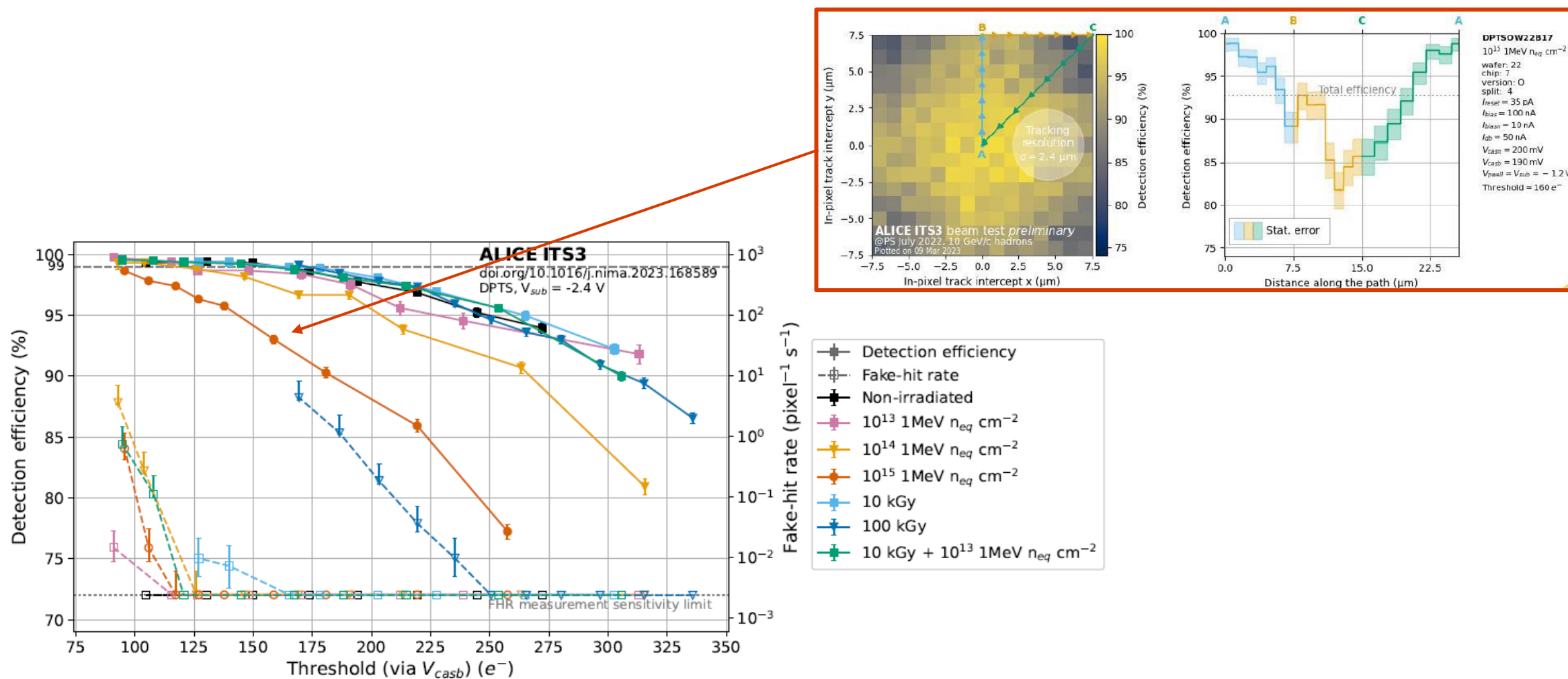
DPTS: Digital Pixel Test Structure



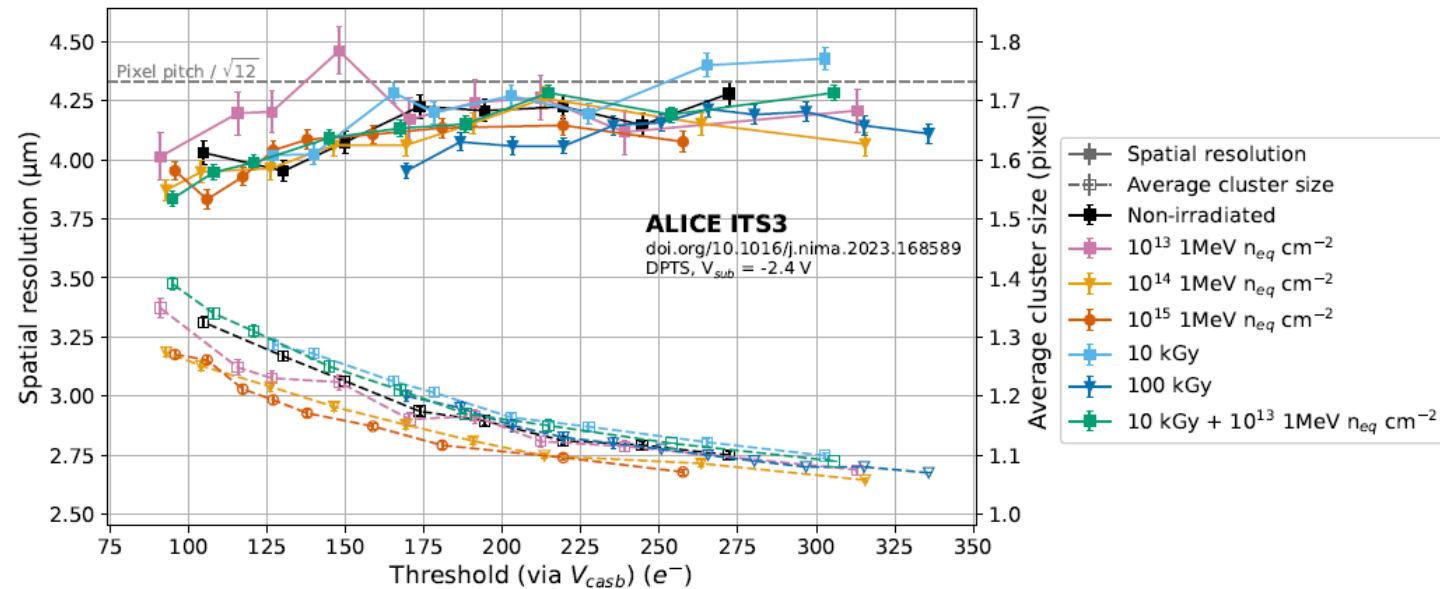
- 32×32 pixel matrix, 15 μm pitch
- Asynchronous digital readout
- Time-encoded pixel position
- Time-over-threshold measurements
- **Goal:** study the in-pixel front-end



MLR1 – Radiation hardness



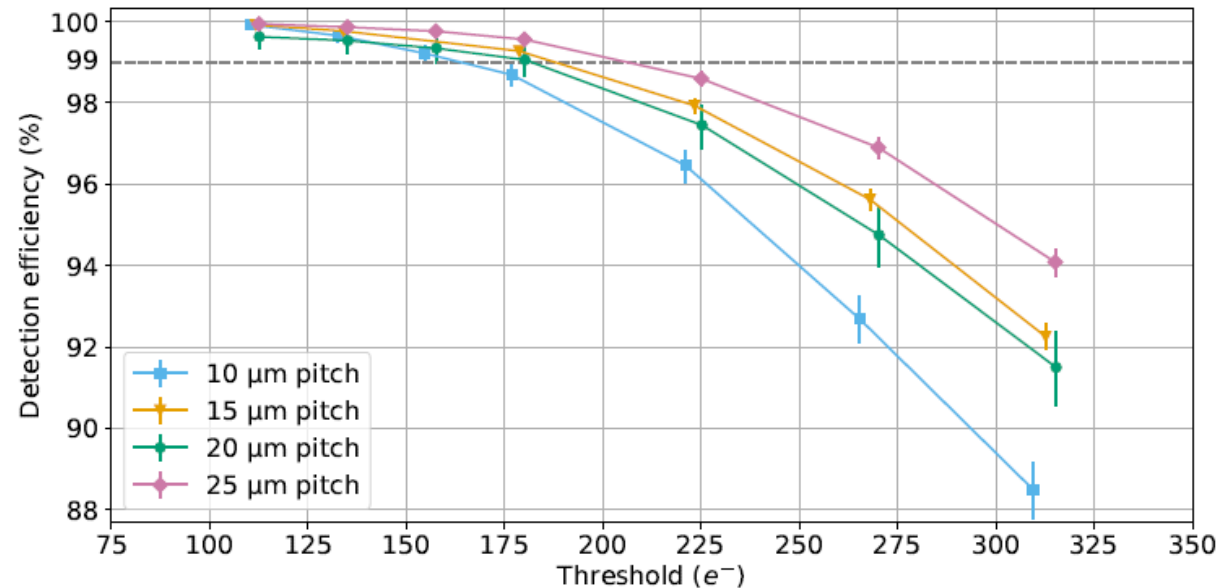
MLR1 – Spatial resolution



Spatial resolution and average cluster size Vs threshold and irradiation levels, as measured in testbeams on 15 μm pitch DPTS:

- The spatial resolution measured slightly better than pixel pitch / $\sqrt{12}$ (no degradation with received dose)
- Slight systematic decrease of average cluster size with the increasing non-ionising radiation dose

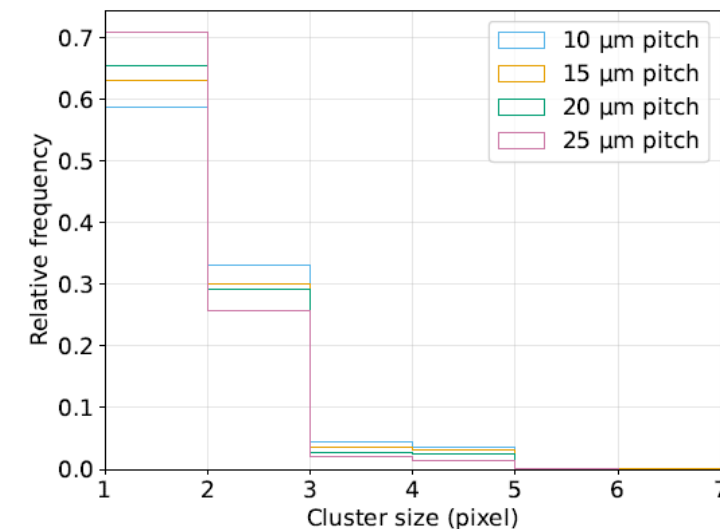
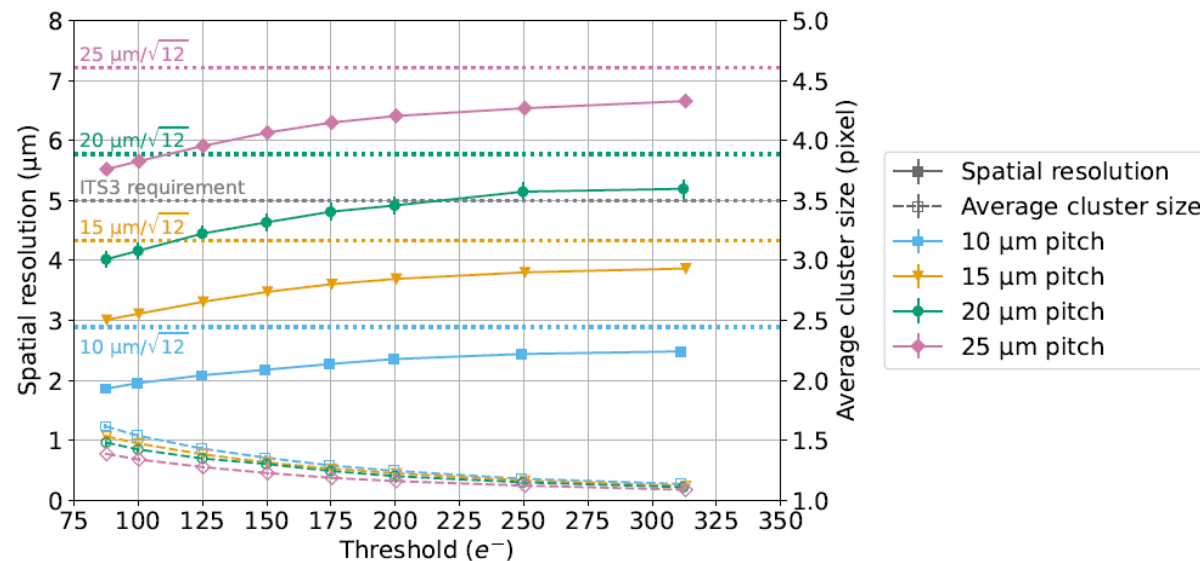
MLR1 – pixel pitch



The detection efficiency increases with increasing pixel pitch

- Relative fraction of pixel border area decreasing with the increasing pixel pitch
- Pixel border only being less efficient due to geometrical sharing of the charge among neighboring pixels

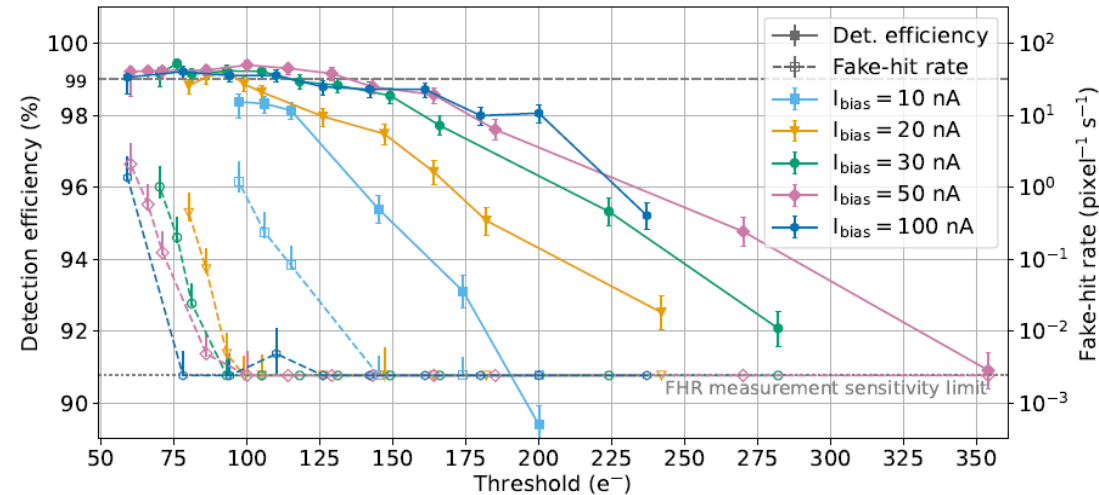
MLR1 – pixel pitch



Spatial resolution and average cluster size VS threshold and pixel pitch, measured with APTS

- More charge sharing → improved resolution
- Considering the ITS3 target pitch size of $20.8 \mu\text{m} \times 22.8 \mu\text{m}$, the expected spatial resolution is about **5 μm** for a threshold of 100 e^-
- For the ITS3 it is expected to have on average less than **1.5 pixels** above threshold for a minimum ionizing particle hit

MLR1 – Power consumption

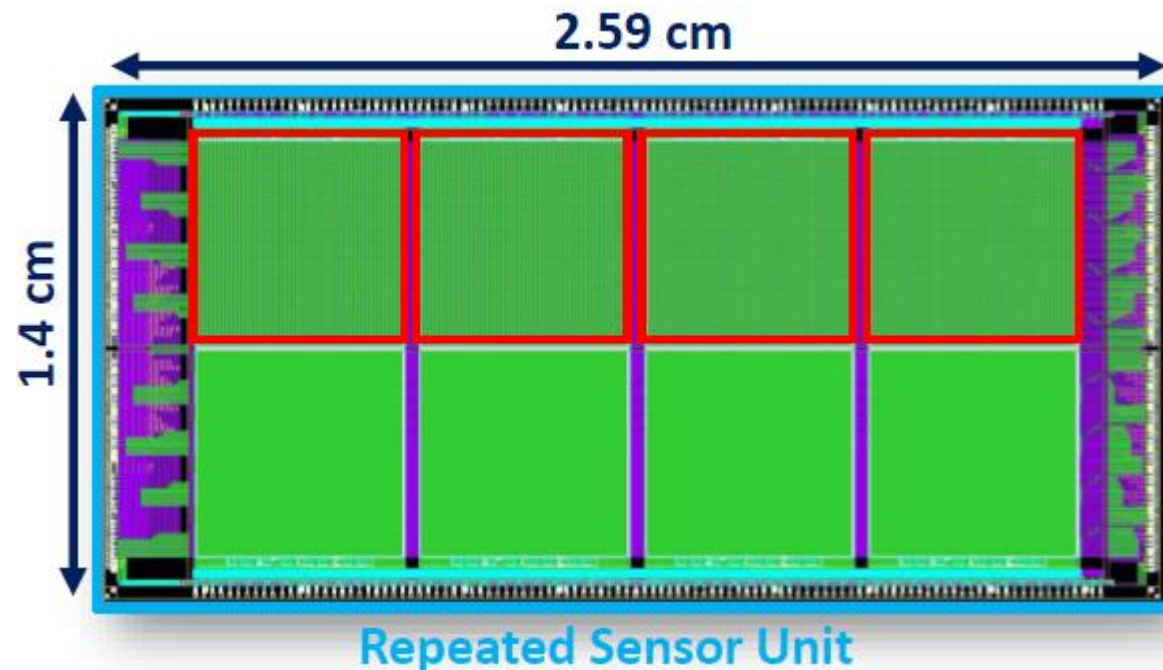


DPTS front end designed to investigate power consumption (ITS3 target < 40 mW/cm²) :

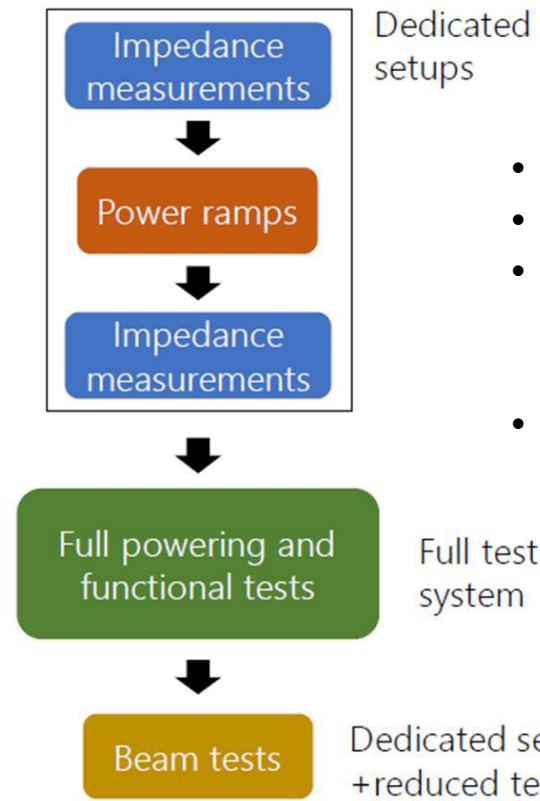
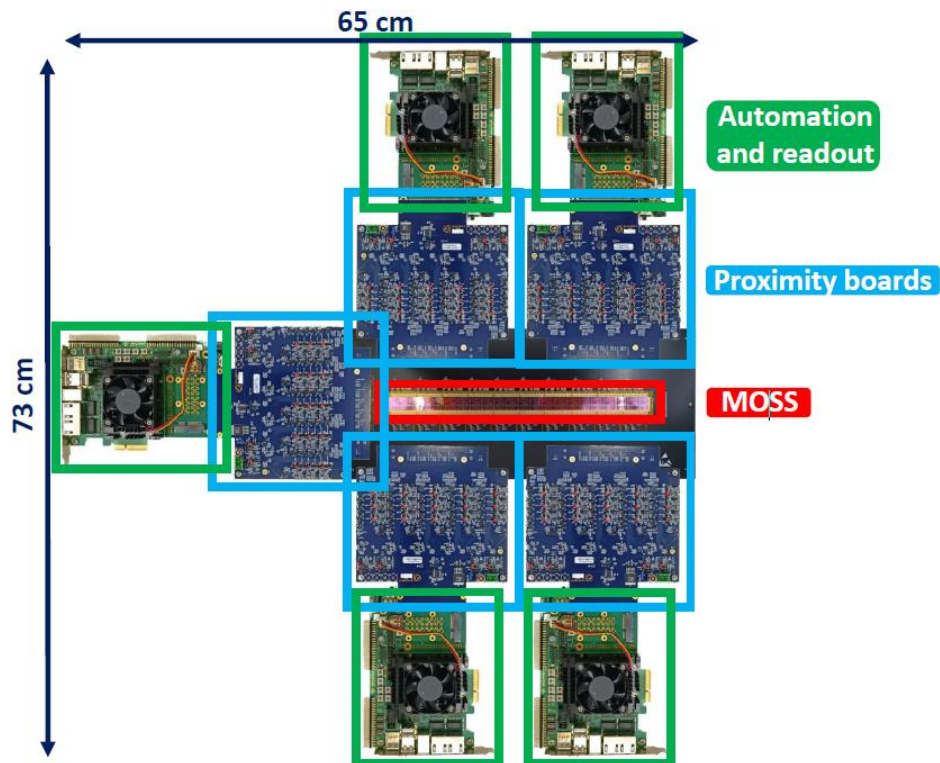
- At least a main current I_{bias} of 30 nA is needed
- 16 mW/cm² as measured on 15 μm pixel
- 7.6 mW/cm² if projected to the final ITS3 sensor pixel pitch

MOSS structure

- 10 Repeated Sensor Units (RSU)
 - 2 Half Units (HU) with 4 regions (each with different electronics)
 - TOP regions: 256 x 256 pixels, 22.5 μm pitch
 - BOTTOM regions: 320 x 320 pixels, 18 μm pitch



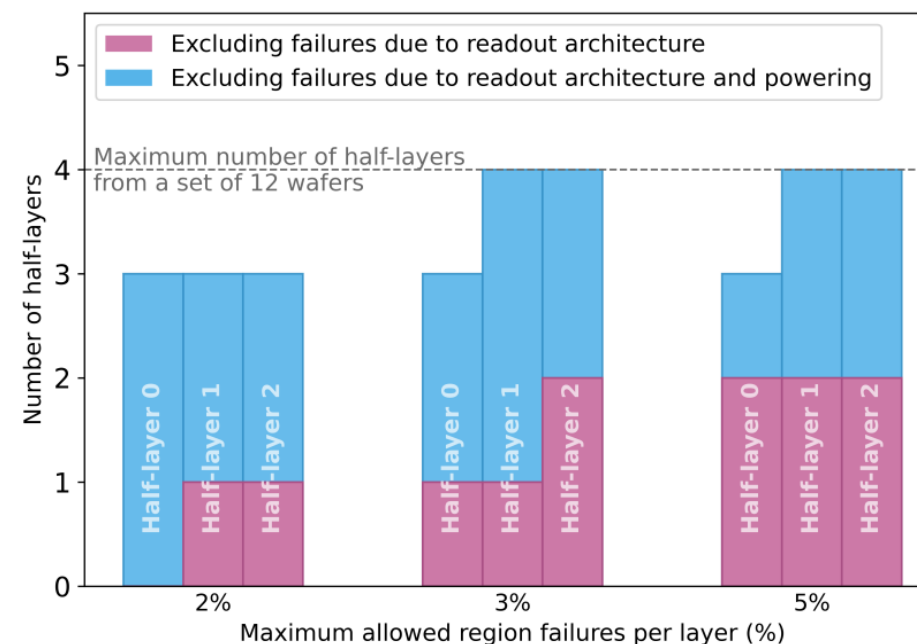
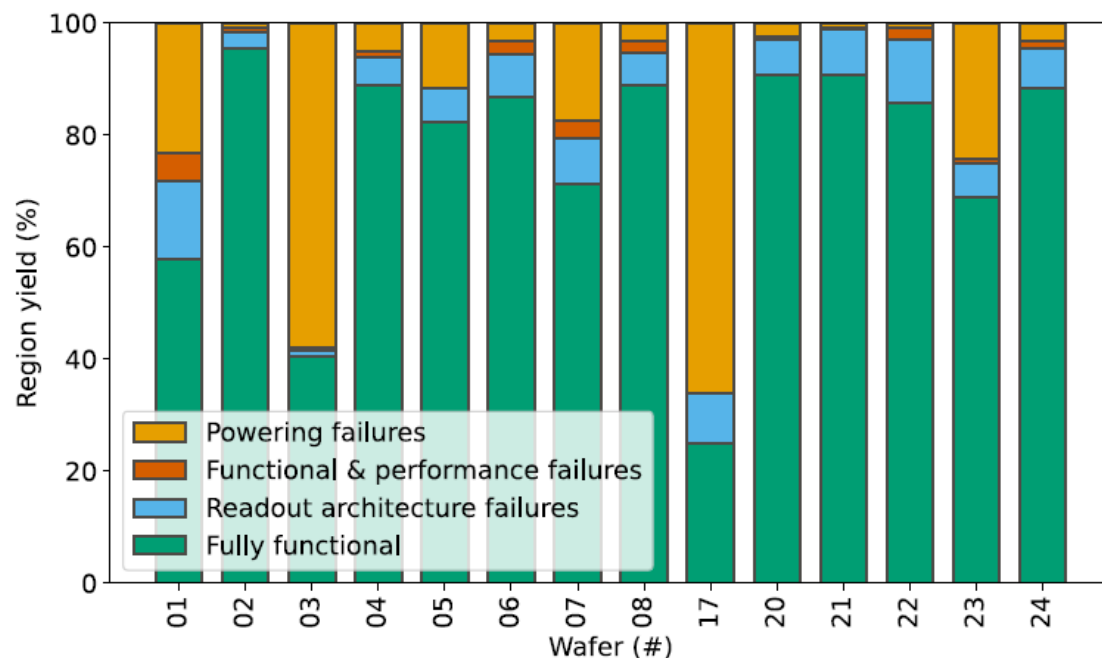
MOSS tests



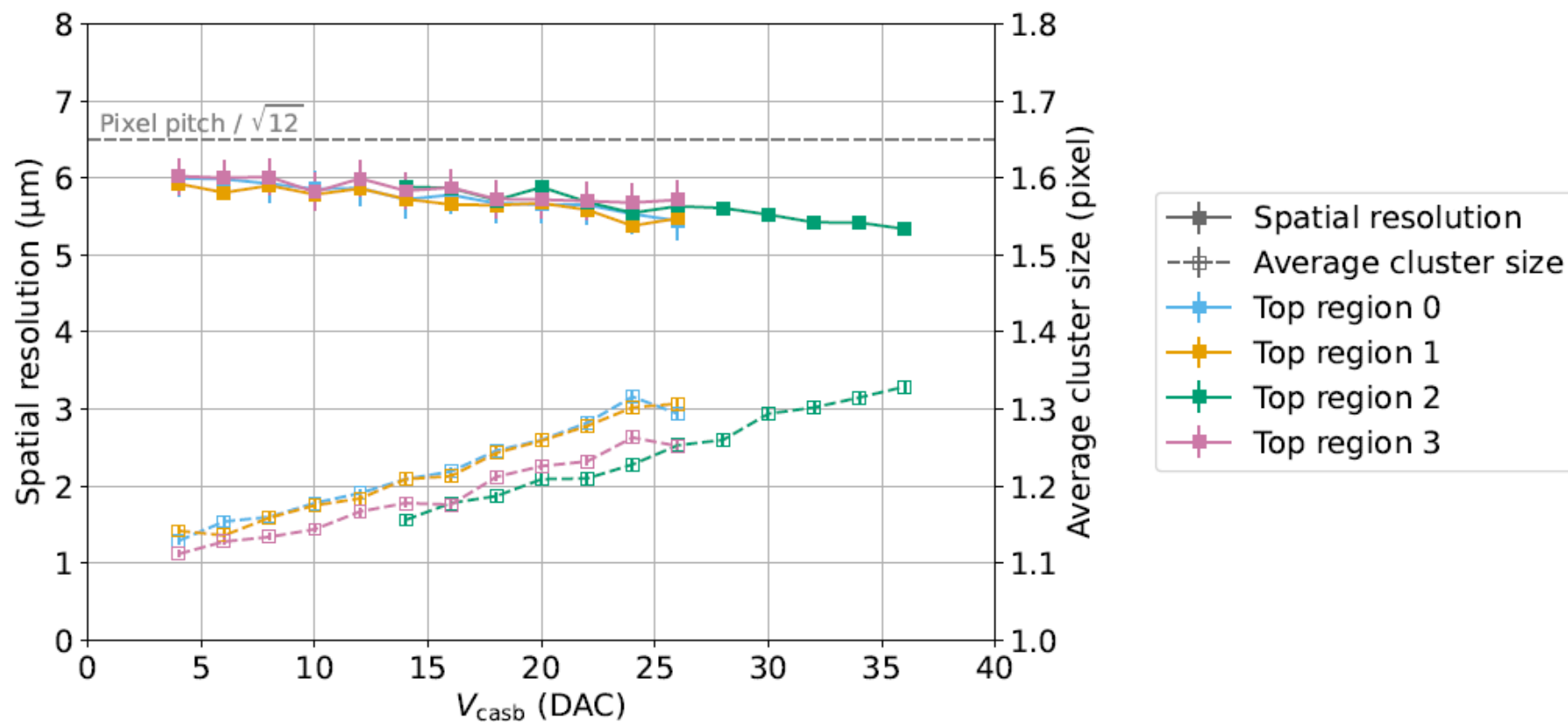
- MOSS: 2200 bonds!
- Need dedicated large-scale test setup
- Several functional tests on all 82 MOSS
Yield ~89 % (~98% excluding readout issues)
- Good performance and uniform behavior
NO wafer or sensor position dependence

MOSS tests - Yield

Wafer-to-wafer variations



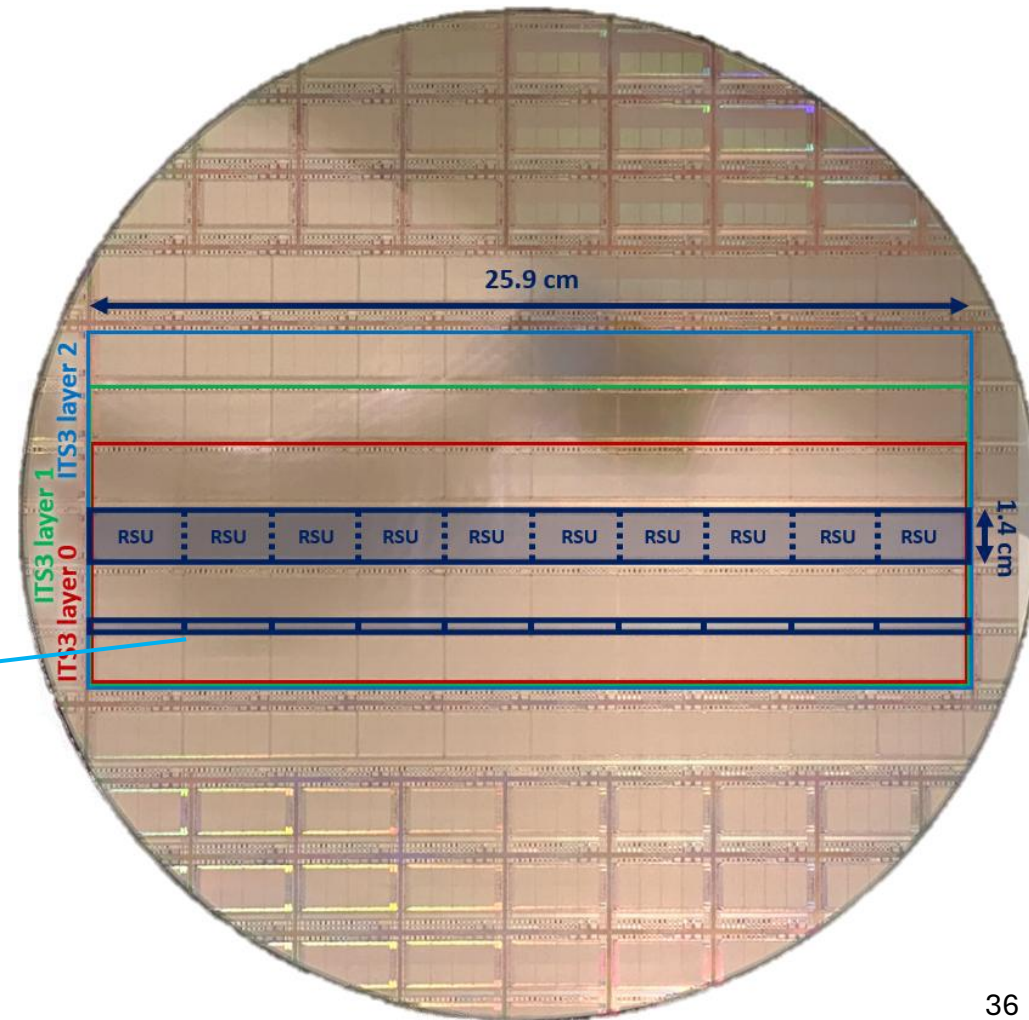
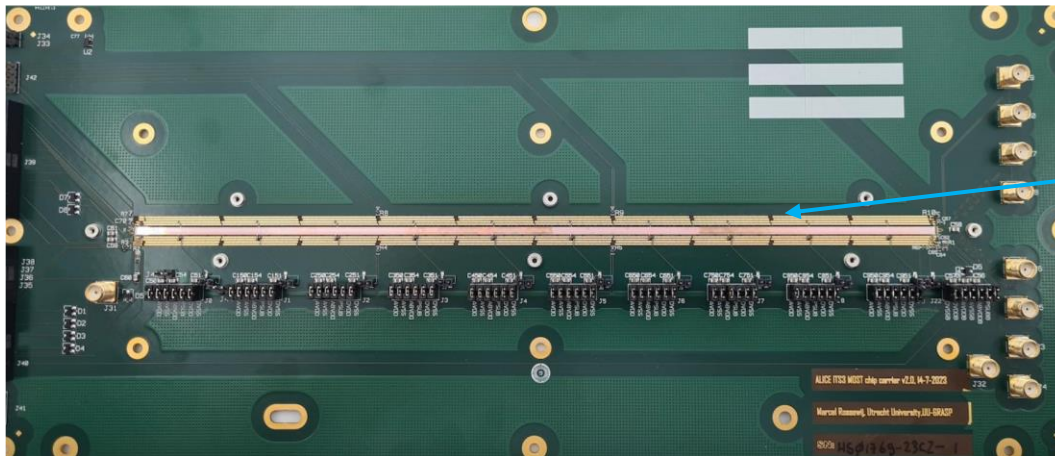
MOSS tests – spatial resolution



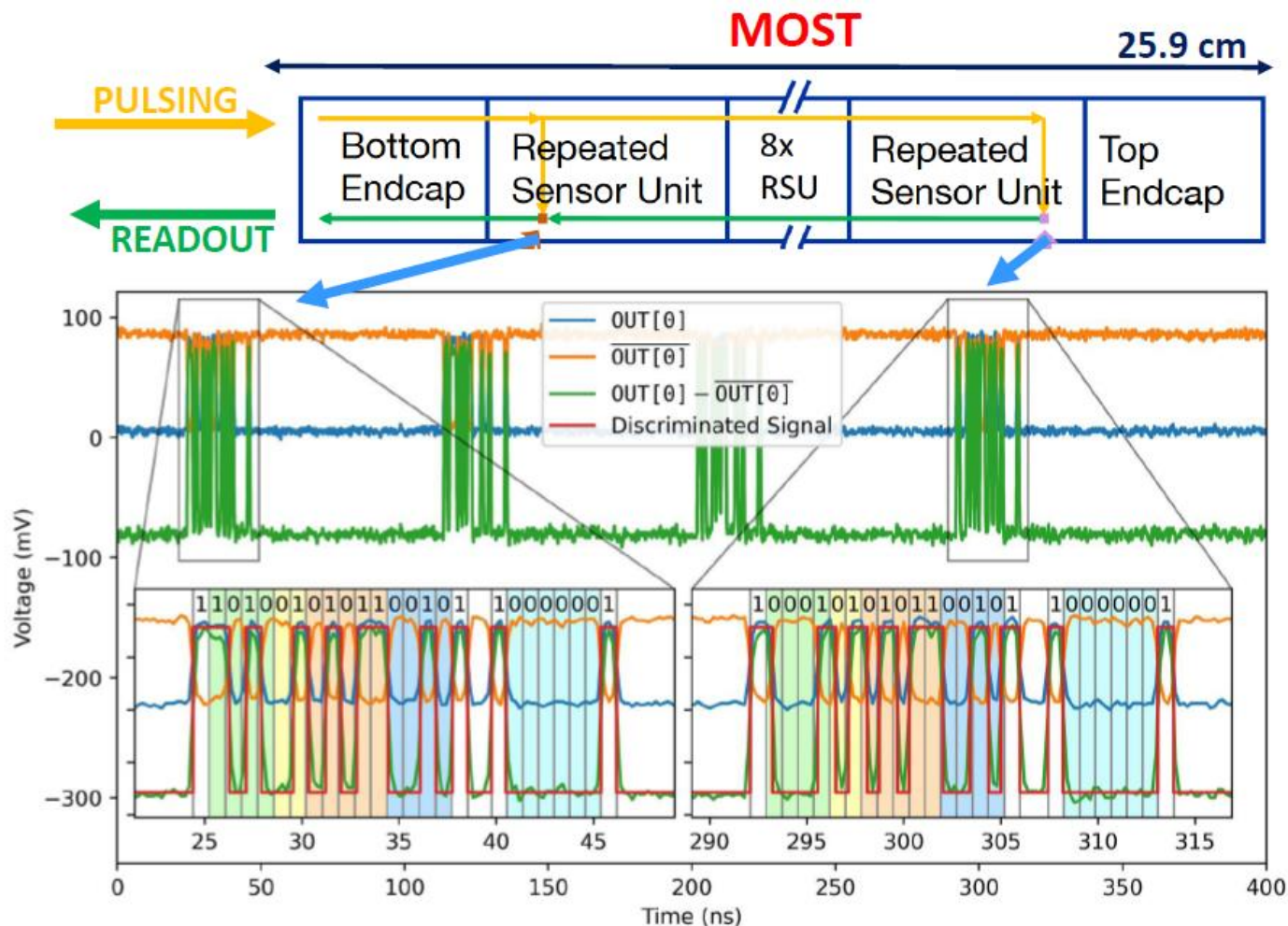
MOST tests

MOⁿolithic Stⁱched sensor with Tⁱming (MOST)

- Denser layout and power segmentation
- $25.9 \times 0.25 \text{ cm}^2$
- 0.9 million pixels, $18 \mu\text{m}$ pitch
- Aimed at testing the transmission quality of high-speed data over the full length of the ITS3



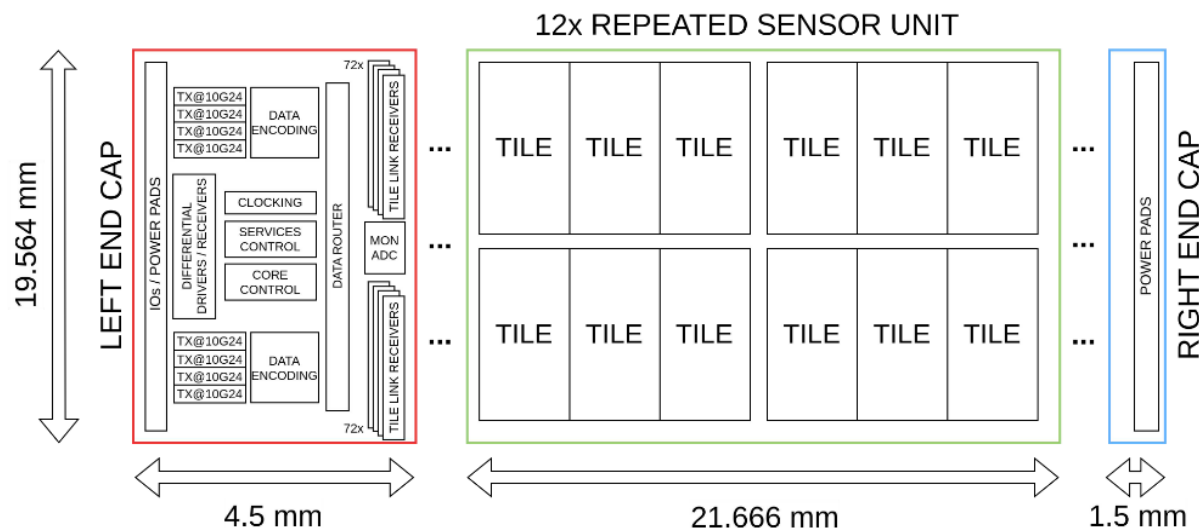
MOST tests



Test of the **data transmission across the full length**

- Pulsing and readout of different MOST RSUs
- Data transmission verified:
 - 1) 1 Gbit/s
 - 2) over 25.9 cm
 - 3) across 10 stitched RSU

MOSAIX architecture details



LEC:

- power pads
- data/control I/O
- 8 x 10.24 Gb/s serializers
- on-chip ADC for monitoring

12 RSUs:

- pixel matrix: 12 tiles, individually powered and read-out
- 12 variants of analog front front-end (1 per tile) for optimization studies
- Independent operation improves reliability and yields

REC:

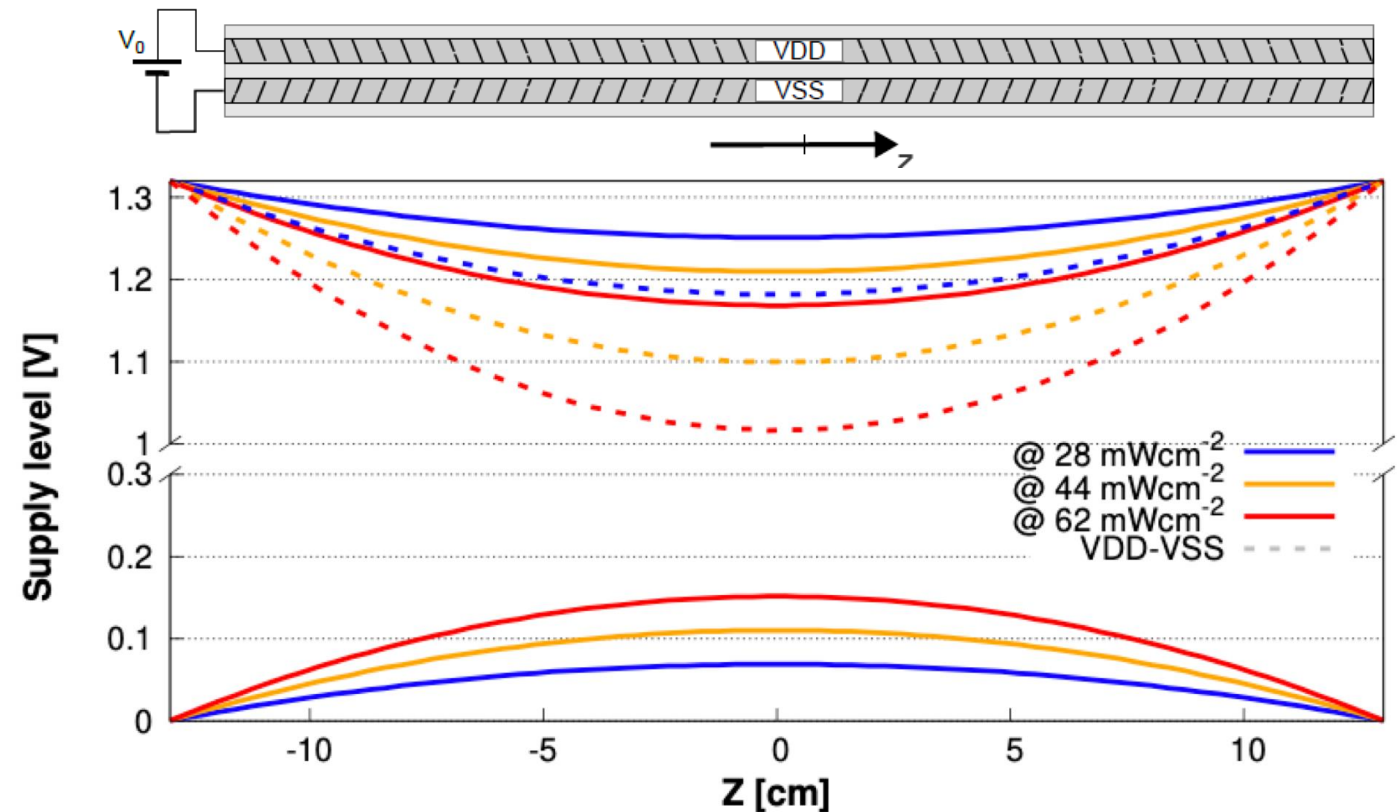
- power pads (for supply redundancy)

MOSAIX powering challenges



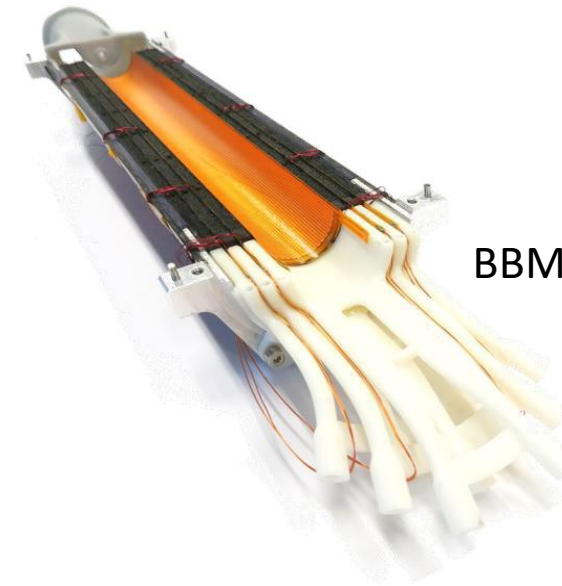
Challenges:

- Voltage drops on the on-chip metals of the CMOS stack significant
- Complex segmentation in many independent domains (tiles)

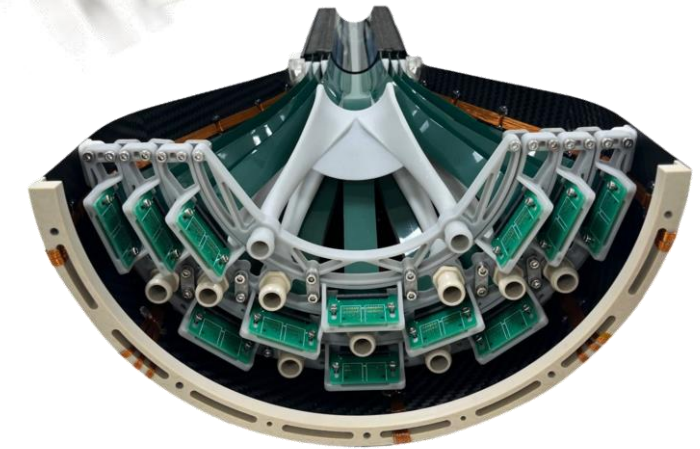


Development strategy

- **BreadBoard Models (BBMs)**
 - Initial prototypes representing selected features of the final design
- **Engineering Models (EMs)**
 - Used for design development; composed of a mix of final-grade and commercial components
- **Qualification Models (QMs)**
 - Fully integrated, final-grade assemblies including MOSAIX sensors (final full functional prototype), used for qualification tests
- **Final Models (FMs)**
 - Two final half-detectors for installation, plus two spare half-detectors



BBM



Full scale EM

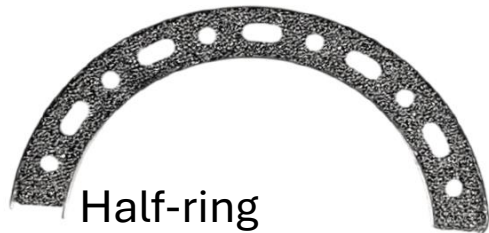
Mechanics and cooling solutions

Ultra-light mechanics → material budget record

Carbon foam used as support and radiator:

- Carbon (RVC) Duocel® for mechanical support
- Allcomp K9 standard density as cooling radiator

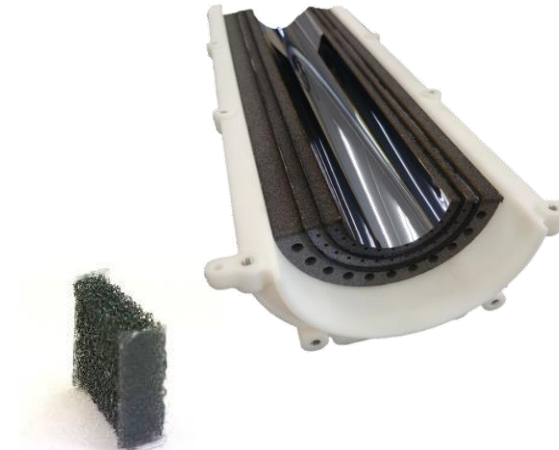
Longerons
(Allcomp K9 SD)



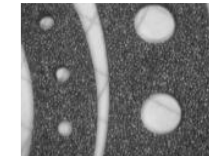
Half-ring
(ERG Duocel Carbon)



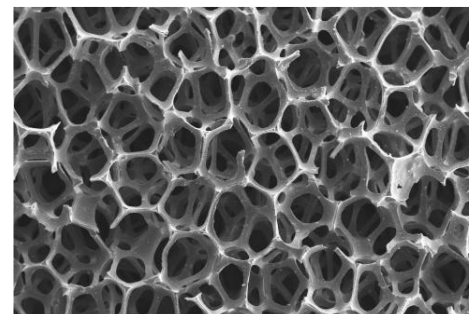
Half-ring
(Allcomp K9 SD)



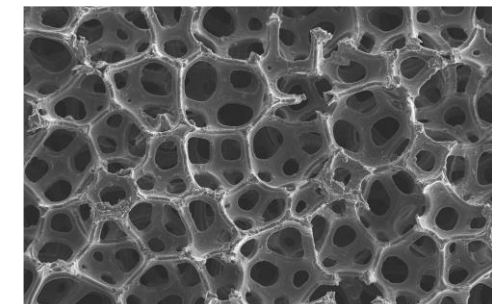
ERG Carbon @Duocel
 $\rho = 0.045 \text{ kg/dm}^3$
 $k = 0.033 \text{ W/m}\cdot\text{K}$



K9 Standard Density
 $\rho = 0.2\text{-}0.26 \text{ kg/dm}^3$
 $k = >17 \text{ W/m}\cdot\text{K}$



Support

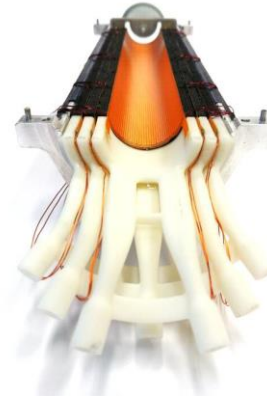


Support & Cooling

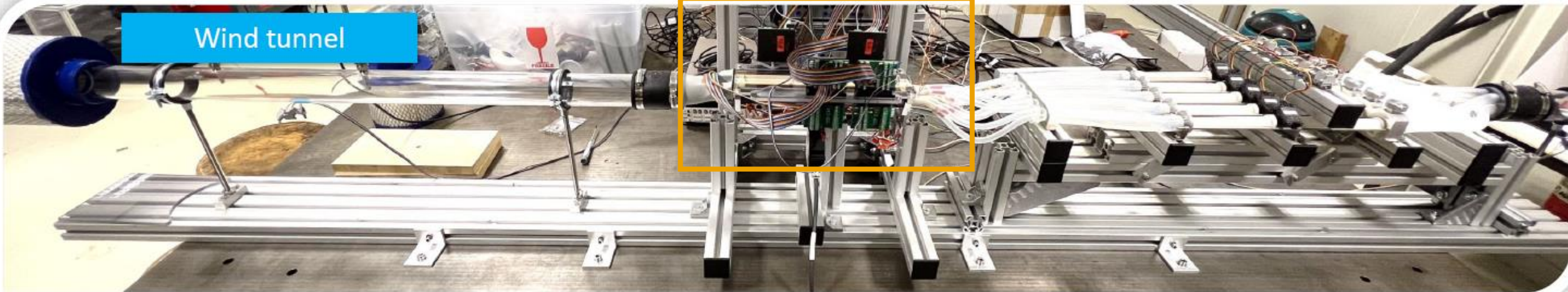
Wind tunnel: cooling test

ITS3 Breadboard Model 3 for thermal characterisation

- Copper heating traces on silicon in polyimide
- Temperature variation can be kept $< 5\text{K}$



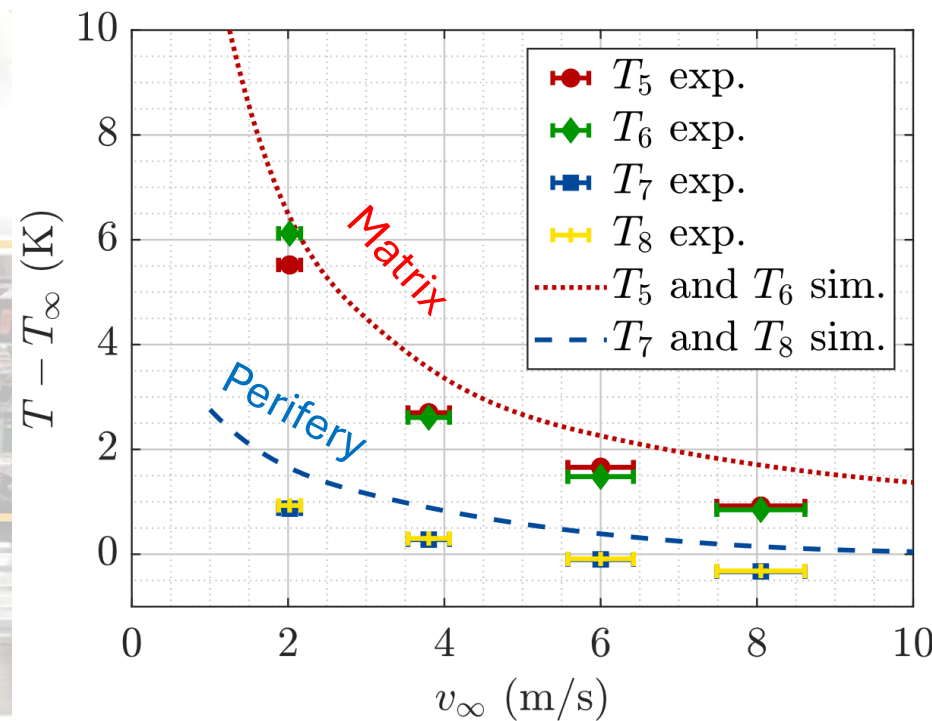
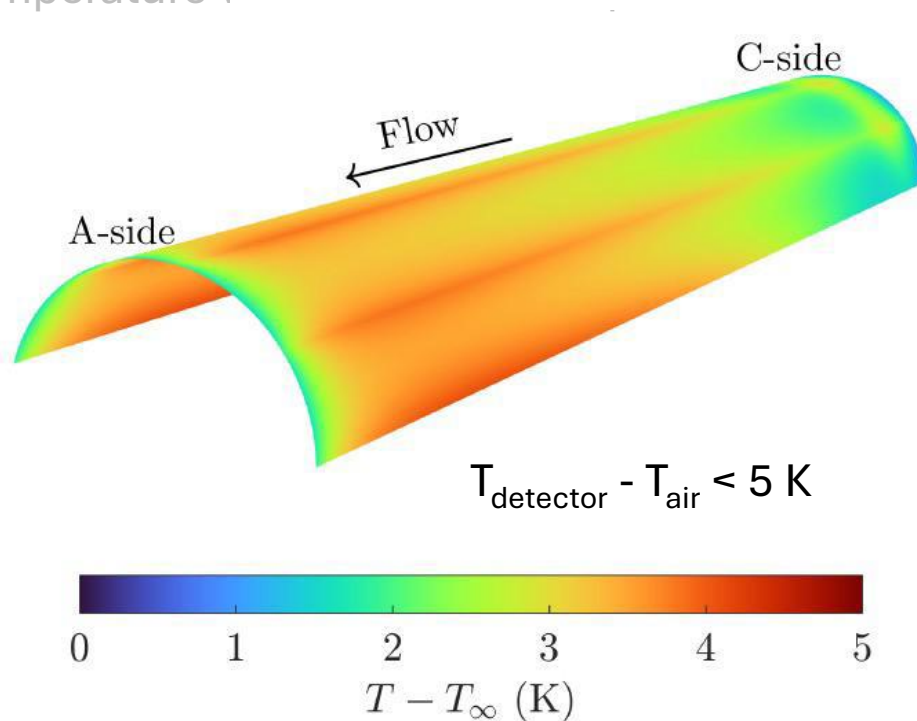
Wind tunnel



Wind tunnel: cooling test

ITS3 Breadboard
characterisation

- Copper heat sink
- polyimide
- Temperature \

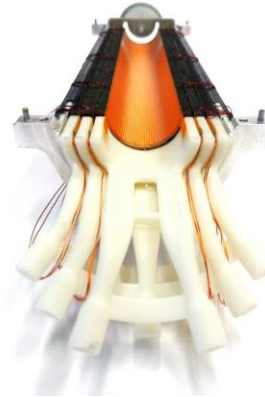


Cooling 25 mW/cm²

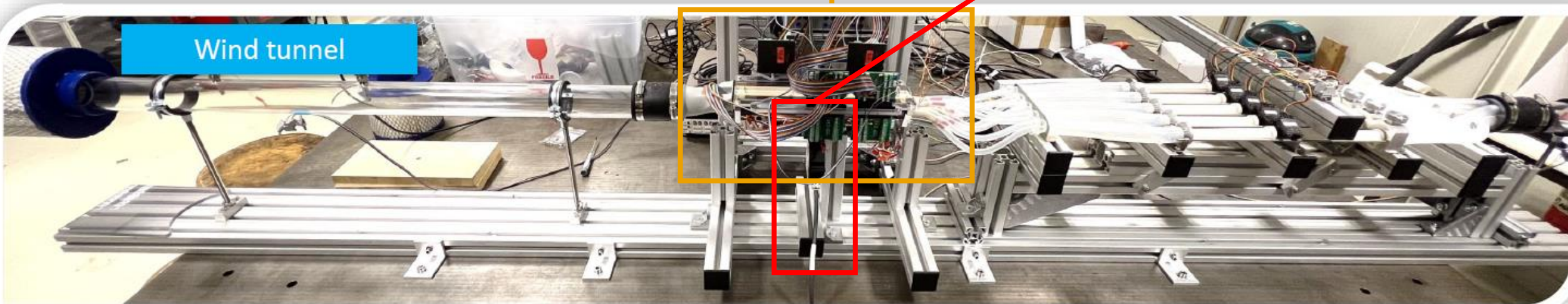
Wind tunnel: cooling test

ITS3 Breadboard Model 3 for thermal characterisation

- Copper heating traces on silicon in polyimide
- Temperature variation can be kept $< 5\text{K}$



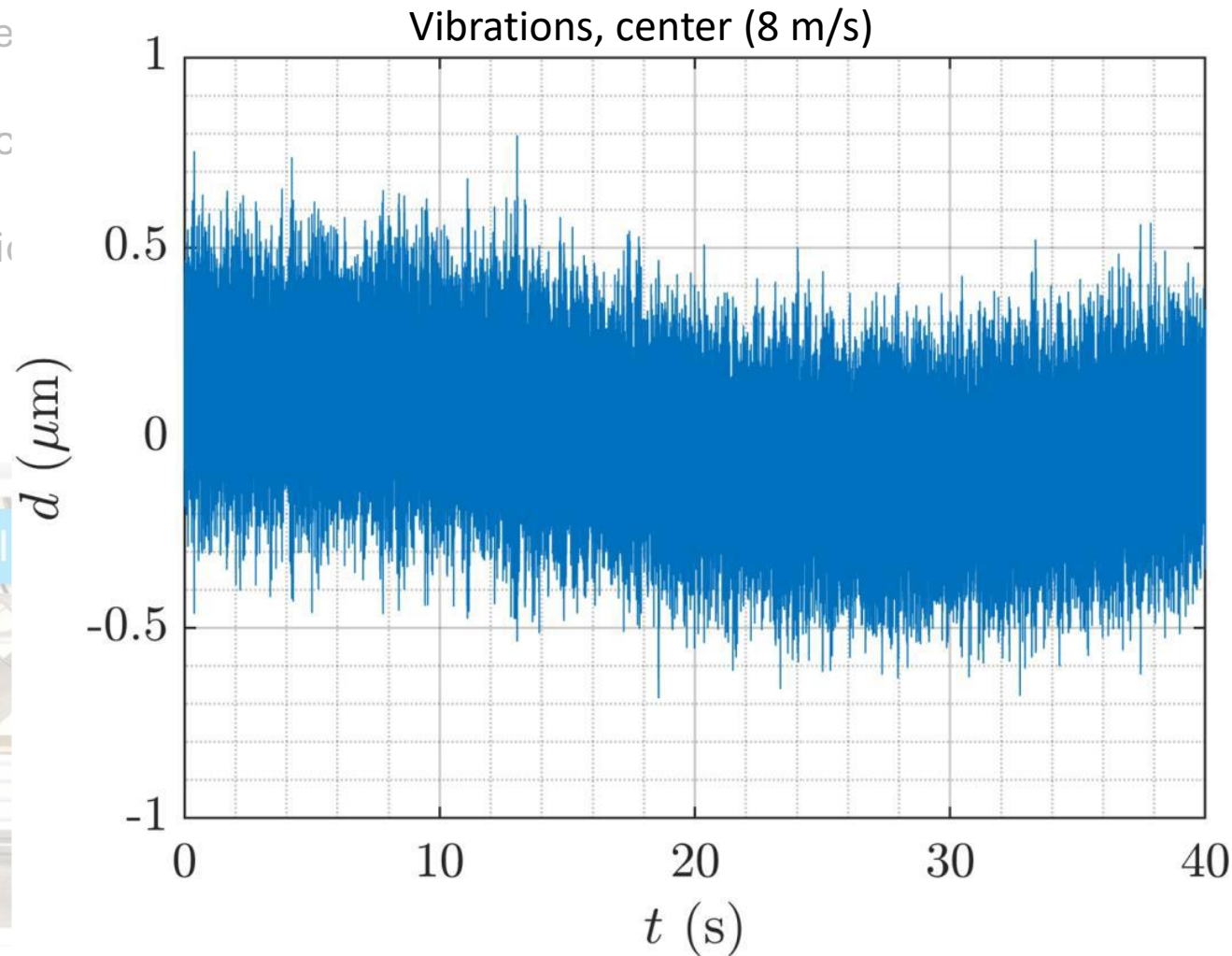
- Laser measurement machine for vibration analysis



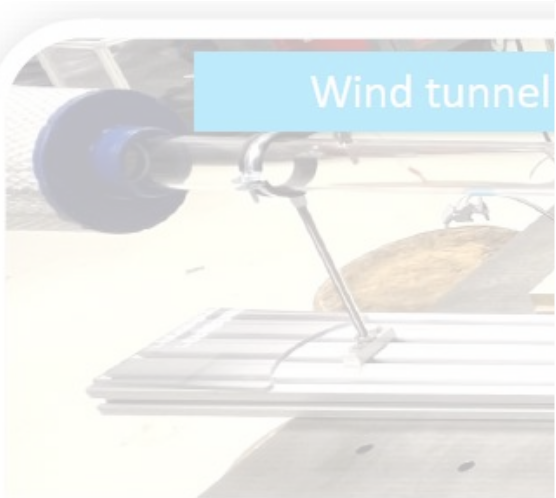
Wind tunnel: cooling test

ITS3 Breadboard Mode
characterisation

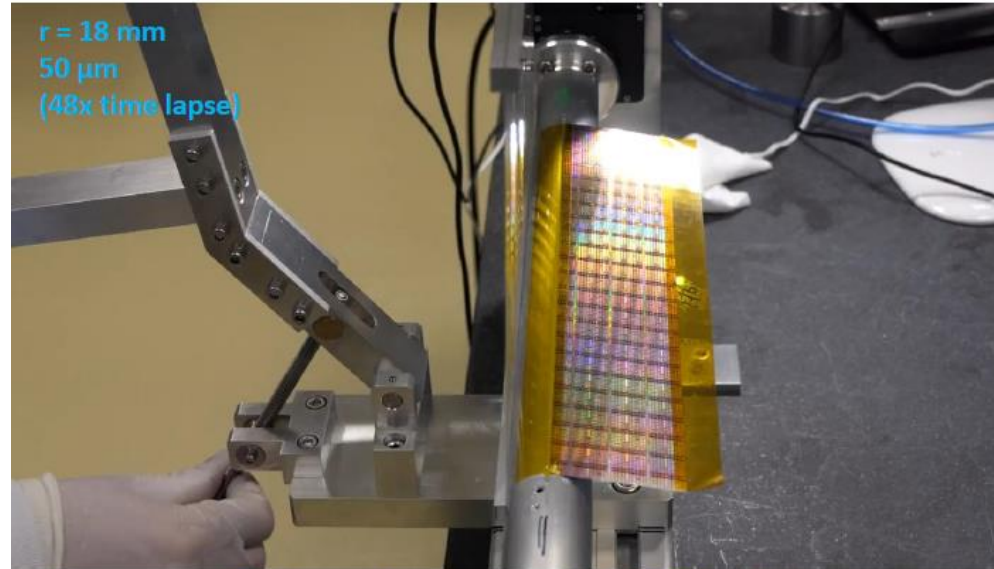
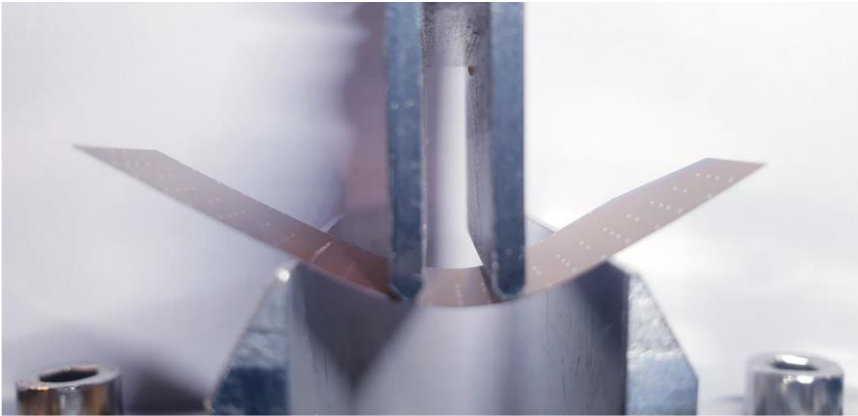
- Copper heating trace
polyimide
- Temperature variation



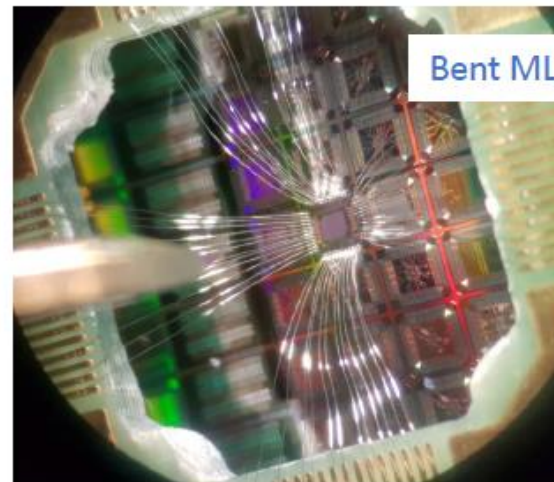
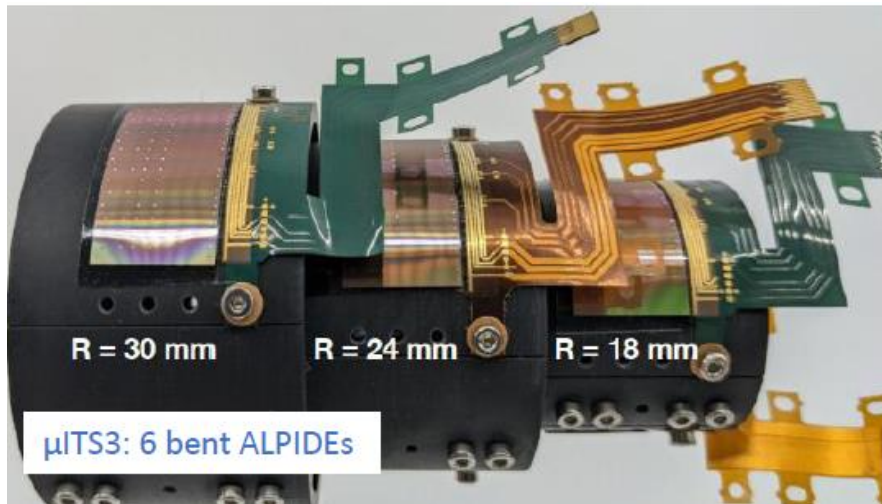
Laser
measurement
machine for
vibration
analysis



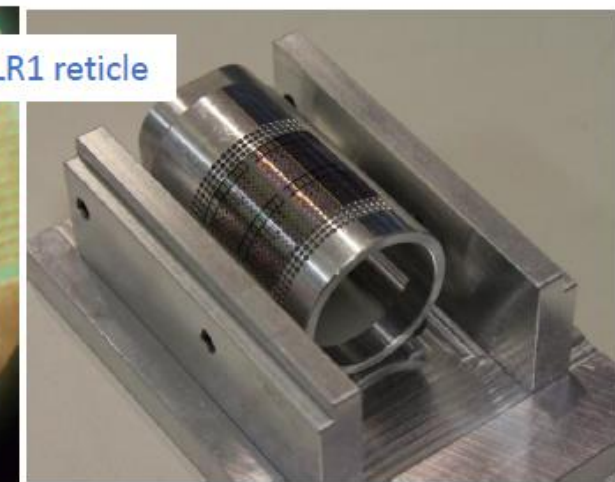
Bending



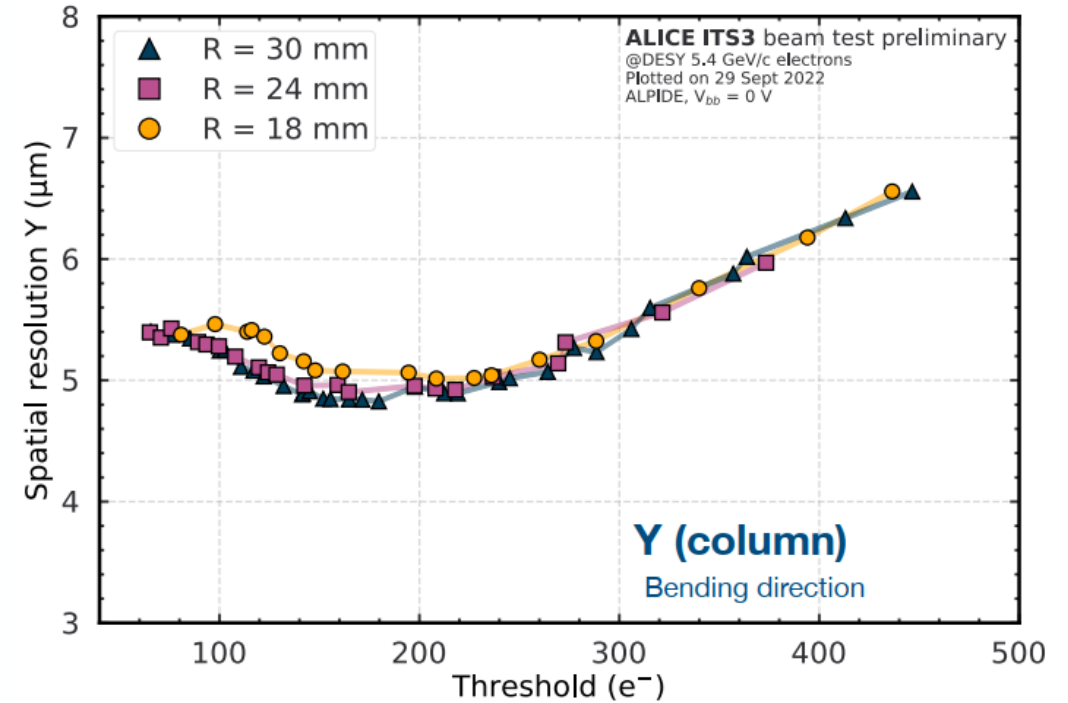
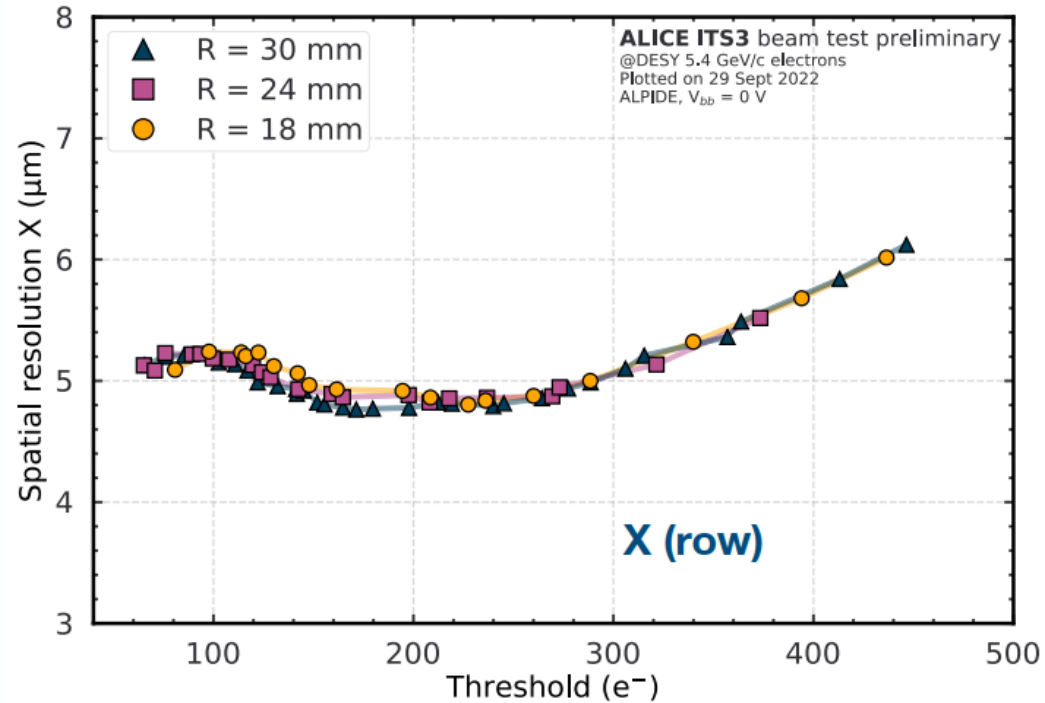
Bending wafer size sensor (using MLR1 wafer)



Bent MLR1 reticle



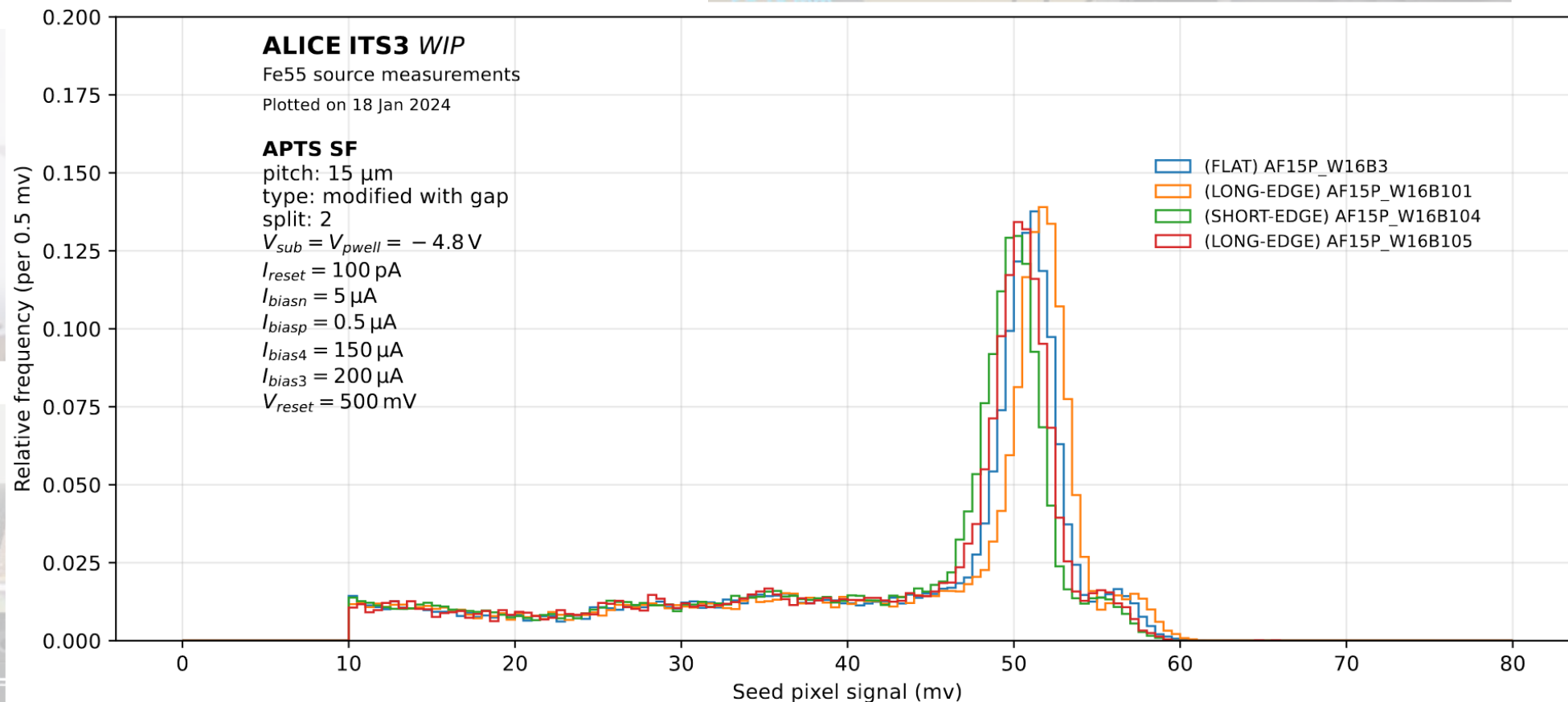
Bending



μITS3 Spatial Resolution



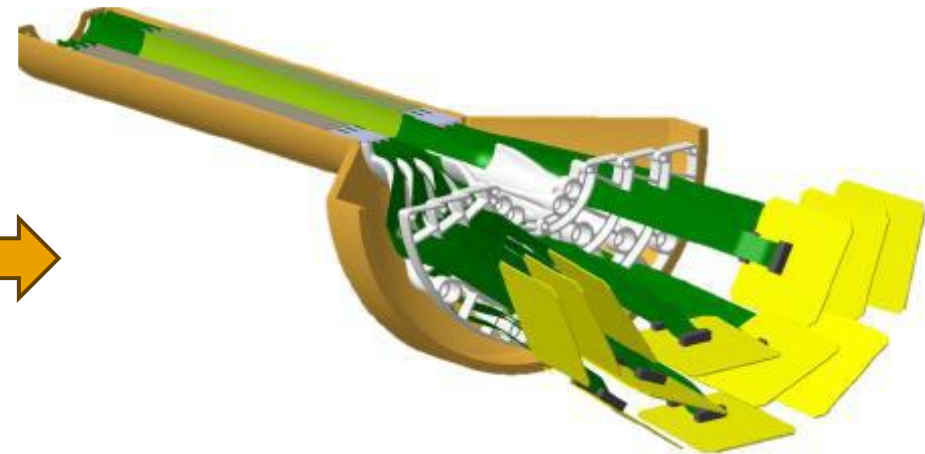
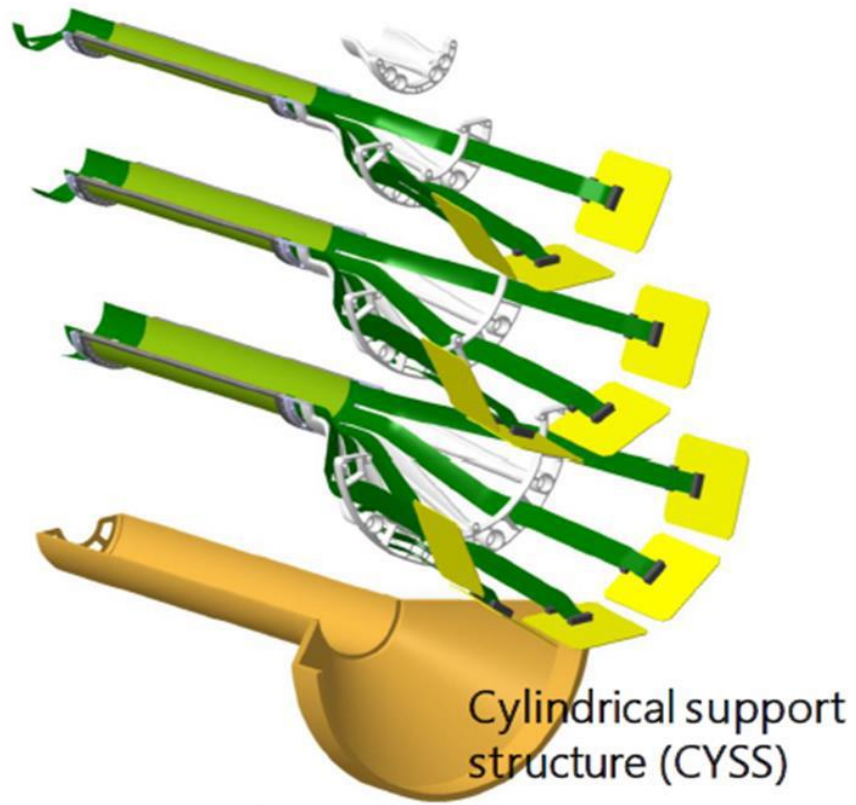
Bending



μITS3 : 6 bent ALPIDEs

Bent analog pixel test structures

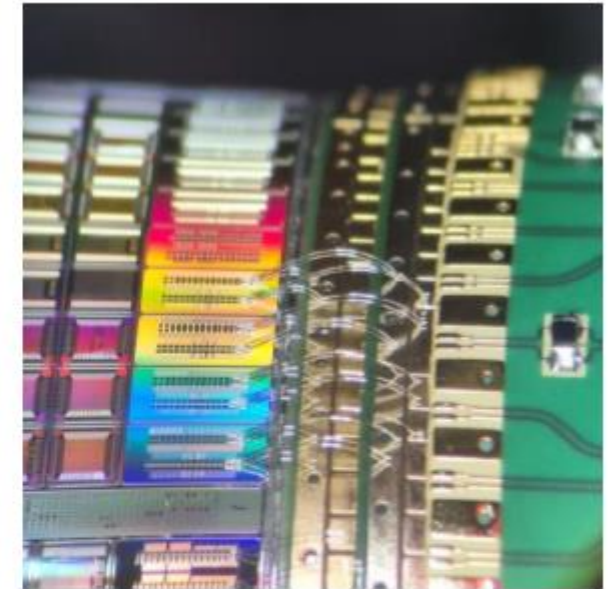
ITS3 Layout



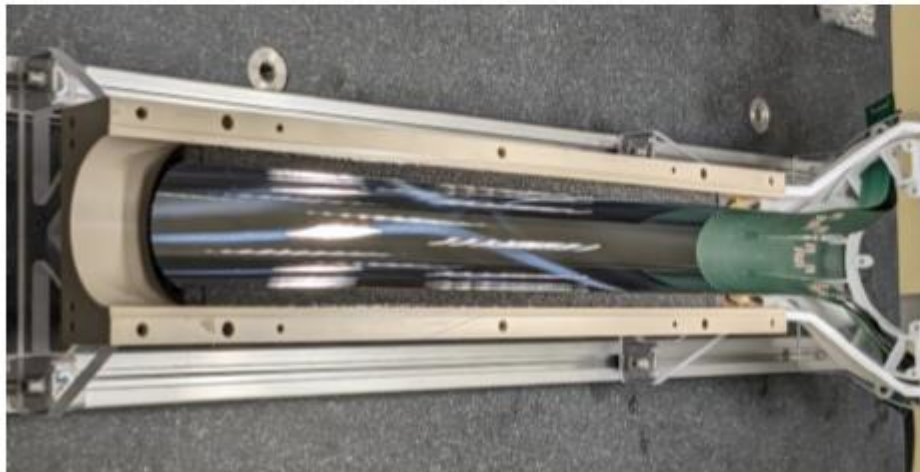
ITS3 assembly tests



FPC and Sensor on jig



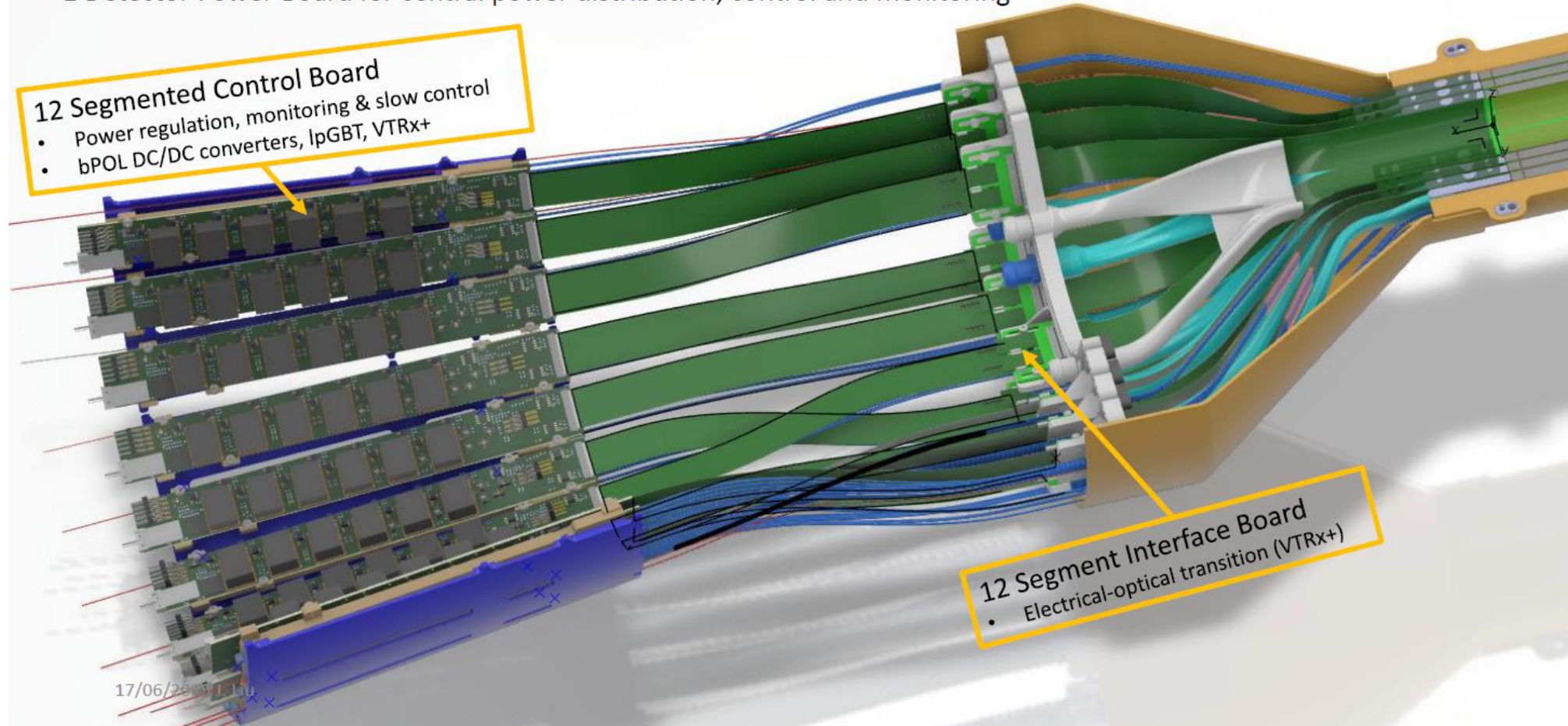
Wire bondings



First layer assembled

Detector Service Electronics

- 1 Detector Power Board for central power distribution, control and monitoring





ITS3 general parameters

Beampipe inner/outer radius (mm)	16.0/16.5		
IB Layer parameters	Layer 0	Layer 1	Layer 2
Radial position (mm)	19.0	25.2	31.5
Length (sensitive area) (mm)	260	260	260
Pseudo-rapidity coverage ^a	± 2.5	± 2.3	± 2.0
Active area (cm ²)	305	407	507
Pixel sensors dimensions (mm ²)	266×58.7	266×78.3	266×97.8
Number of pixel sensors / layer	2		
Material budget ($\%X_0$ / layer)	0.07		
Silicon thickness (μm / layer)	≤ 50		
Pixel size (μm^2)	$O(20 \times 22.5)$		
Power density (mW/cm ²)	40		
NIEL (1 MeV n_{eq} cm ⁻²)	10^{13}		
TID (kGray)	10		

^a The pseudorapidity coverage of the detector layers refers to tracks originating from a collision at the nominal interaction point ($z = 0$).